

#### **ADVANCED COMMUNICATIONS & SENSING**

**DATASHEET** 

#### **DESCRIPTION**

The SX8723S is a data acquisition system based on Semtech's low power ZoomingADC™ technology. It directly connects most types of miniature sensors with a general purpose microcontroller.

With 2 differential inputs, it can adapt to multiple sensor systems. Its digital outputs are used to bias or reset the sensing elements.

#### **APPLICATIONS**

- Industrial pressure sensing
- Industrial temperature sensing
- Industrial chemical sensing
- Barometer
- Compass

#### **FEATURES**

- Up to 16-bit differential data acquisition
- Programmable gain: (1/12 to 1000)
- Sensor offset compensation up to 15 times full scale of input signal
- 2 differential or 4 single-ended signal inputs
- Programmable Resolution versus Speed versus Supply current
- Internal time base
- Low-power (250 uA for 16b @ 250 S/s)
- SPI interface, 2 Mbps serial clock

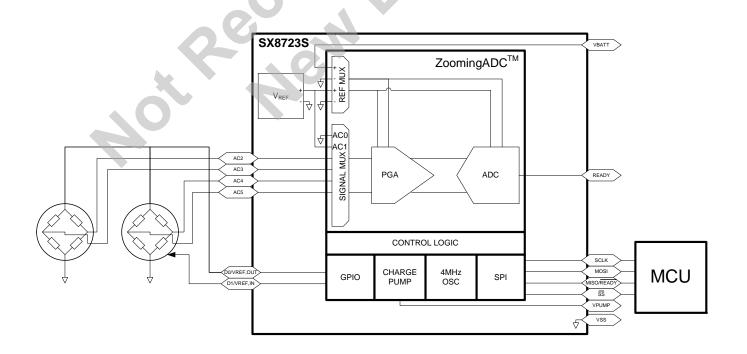
#### **ORDERING INFORMATION**

DEVICE	PACKAGE	REEL QUANTITY		
SX8723SWLTDT	MLPQ-W-16 4x4	1000		

<sup>-</sup> Available in tape and reel only

- WEEE/RoHS compliant, Pb-Free and Halogen Free.

#### **FUNCTIONAL BLOC DIAGRAM**





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# **ELECTRICAL SPECIFICATIONS**

# 1 Absolute Maximum Ratings

Note

The Absolute Maximum Ratings, in table below, are stress ratings only. Functional operation of the device at conditions other than those indicated in the Operating Conditions sections of this specification is not implied.

Exposure to the absolute maximum ratings, where different to the operating conditions, for an extended period may reduce the reliability or useful lifetime of the product.

**Table 1. Absolute Maximum Ratings** 

Parameter	Symbol	Condition	Min	Max	Units
Power supply	VBATT		Vss - 0.3	6.5	V
Storage temperature	Tstore		-55	150	°C
Temperature under bias	TBIAS		-40	140	°C
nput voltage	VINABS	All inputs	Vss - 300	VBATT + 300	mV
Peak reflow temperature	Тркс			260	°C
ESD conditions	ESDнвм	Human Body Model ESD	2000		V
_atchup			100		mA



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# **2 Operating Conditions**

Unless otherwise specified: VREF,ADC = VBATT, VIN = 0V, Over-sampling frequency fS = 250 kHz, PGA3 on with Gain = 1, PGA1&PGA2 off, offsets GDOff2 = GDOff3 = 0. Power operation: normal (IbAmpAdc[1:0] = IbAmpPga[1:0] = '01').

For resolution n = 12 bits: OSR = 32 and NELCONV = 4.

For resolution n = 16 bits: OSR = 256 and NELCONV = 2.

Bandgap chopped at NELCONV rate. If VBATT < 3V, Charge Pump is forced on. If VBATT > 3V, Charge Pump is forced off.

#### **Table 2.** Operating conditions limits

Parameter	Symbol	Comment/Condition	Min	Тур	Max	Unit
Power supply	VBATT		2.4		5.5	V
Operating temperature	Тор		-40		125	°C

#### **Table 3. Electrical Characteristics**

Parameter	Symbol	Comment/Condition	Min	Тур	Max	Unit
CURRENT CONSUMPTION <sup>1</sup>			7/1			
		16 b @ 250 Sample/s ADC, fs = 125 kHz	9)	250	300	
Active current, 5.5V	IOP55	16 b @ 1kSample/s PGA3 + ADC, fs = 500 kHz		650	850	μΑ
		16 b + gain 1000 @ 1kSample/s PGA3,2,1 + ADC, fs = 500 kHz		1000	1250	
		16 b @ 250 Sample/s ADC, fs = 125 kHz		150		
Active current, 3.3V	IOP33	16 b @ 1 kSample/s PGA3 + ADC, fs = 500 kHz		500		μΑ
		16 b + gain 1000 @ 1kSample/s PGA3,2,1 + ADC, fs = 500 kHz		830		
A 0		@25°C		150	250	
Sleep current	ISLEEP	up to 85°C		200		nA
		@125°C		250		
TIME BASE						
Max ADC Over-Sampling frequency	fSmax	@25°C	425	500	575	kHz
ADC Over-Sampling frequency drift	fsт			0.15		%/°C
DIGITAL I/O						
Input logic high	VIH		0.7			VBATT
Input logic low	VIL				0.3	<b>V</b> BATT
Output logic high	Vон	IOH < 4 mA			VBATT-0.4	V
Output logic low	Vol	IoL < 4 mA	0.4			V
Leakages currents						

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#### Table 3. Electrical Characteristics

Parameter	Symbol	Comment/Condition	Min	Тур	Max	Unit	
Input leakage current ILea		Digital input mode, no pull-up or pull-down	-100		100	nA	
VREF: Internal Bandgap Reference							
Absolute output voltage	VBG	VBATT > 3V	1.19	1.22	1.25	V	
Variation over Temperature	VBGT	VBATT > 3V, over Temperature	-1.5		+1.5	%	
Total Output Noise	VBGN	VBATT > 3V			1	mVrms	

<sup>1.</sup> The device can be operated in either active or sleep states. The Sleep state is complete shutdown, but the active state can have a variety of different current consumptions depending on the settings. Some examples are given here: The Sleep state is the default state after power-on-reset. The chip can then be placed into an active state after a Slave Select command on \$\overline{55}\$ pin is received.

#### **Table 4. ZoomingADC Specifications**

Parameter	Symbol	Condition	Min	Тур	Max	Unit
ANALOG INPUT CHARACTERISTICS	•				<u>•</u>	
		Gain=1, OSR=32, VREF=5V. Note 1	-2.42		+2.42	V
Differential Input Voltage Range VIN = VINP-VINN		Gain=100, OSR=32, VREF=5V	-24.2		+24.2	mV
VIIV — VIIVP-VIIVIV		Gain=1000, OSR=32, VREF=5V	-2.42		+2.42	mV
PROGRAMMABLE GAIN AMPLIFIER	•	4		1	•	1
Total PGA Gain	GDтот	Note 1	1/12		1000	V/V
PGA1 Gain	GD1	(see Table 10, page 22)	1		10	V/V
PGA2 Gain	GD2	(see Table 11, page 22)	1		10	V/V
PGA3 Gain	GD3	Step = 1/12 V/V (see <b>Table 12, page 22</b> )	1/12		127/12	V/V
Gain Settings Precision (each stage)		Gain ≥ 1	-3	±0.5	+3	%
Gain Temperature Dependence				±5		ppm/°C
PGA2 Offset	GDoff2	Step = 0.2 V/V (see <b>Table 11, page 22</b> )	-1		+1	V/V
PGA3 Offset	GD0FF3	Step = 1/12 V/V (see <b>Table 12, page 22</b> )	-63/12		+63/12	V/V
Offset Settings Precision (PGA2 or PGA3)		Note 2	-3	±0.5	+3	%
Offset Temperature Dependence				±5		ppm/°C
Input Impedance on ADC	ZINADC		500			kΩ
Input Impedance on PGA1	ZINPGA1	Gain = 1. <b>Note 3</b>	900	1150		kΩ
(see section 11.1, page 48)	ZINPGAT	Gain = 10. <b>Note 3</b>	250	350		kΩ
Input Impedance on DCA2	ZINDCAS	Gain = 1. Note 3	500	1000		kΩ
Input Impedance on PGA2	ZINPGA2	Gain = 10. <b>Note 3</b>	125	270		kΩ
Input Impedance on DCA2	ZINPGA3	Gain = 1. Note 3	500	780		kΩ
Input Impedance on PGA3	ZINPGA3	Gain = 10. <b>Note 3</b>	125	190		kΩ

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#### **Table 4. ZoomingADC Specifications**

Parameter	Symbol	Condition	Min	Тур	Max	Unit
		PGA1. Note 4		205		μV
Output RMS Noise per over-sample		PGA2. Note 4		340		μV
		PGA3. Note 4		365		μV
ADC STATIC PERFORMANCES	1					1
Resolution (No Missing Codes)	n	Note 5 Note 6	6		16	Bits
Gain Error		Note 7		±0.15		%
Offset Error		n = 16 bits. <b>Note 8</b>		±1		LSB
Integral Non-Linearity	INL	resolution n = 12 bits. Note 9		±0.6		LSB
integral Non-Linearity	IINL	resolution n = 16 bits. Note 9		±1.5		LSB
Differential Non-Linearity	DNL	resolution n = 12 bits. <b>Note 10</b>		±0.5		LSB
Differential Non-Linearity	DINL	resolution n = 16 bits. <b>Note 10</b>		±0.5		LSB
Power Supply Rejection Ratio	PSRR	VBATT = 5V +/- 0.3V. <b>Note 11</b>	6	78		dB
DC	FOUN	VBATT = 3V +/- 0.3V. <b>Note 11</b>		72		dB
ADC DYNAMIC PERFORMANCES			97			
Conversion Time	Tconv	n = 12 bits. <b>Note 12</b>		133		fs cycles
Conversion Time		n = 16 bits. <b>Note 12</b>		517		fs cycles
The second part (Counting on March	1/Тарын	n = 12 bits, fs = 250 kHz		1.88		kSps
Throughput Rate (Continuous Mode)	1/Tconv	n = 16 bits, fs = 250 kHz		0.483		kSps
PGA Stabilization Delay		Note 13 (see Table 11, page 22)		OSR		fs cycles
ZADC ANALOG QUIESCENT CURRENT						
ADC Only Consumption	lQ	VBATT = 5.5V/3.3V		285/210		μА
PGA1 Consumption		VBATT = 5.5V/3.3V		104/80		μА
PGA2 Consumption		VBATT = 5.5V/3.3V		67/59		μА
PGA3 Consumption		VBATT = 5.5V/3.3V		98/91		μΑ
ANALOG POWER DISSIPATION: All PGA	As & ADC Act	ive				
Normal Power Mode		VBATT = 5.5V/3.3V. <b>Note 14</b>		4.0/2.0		mW
3/4 Power Reduction Mode		VBATT = 5.5V/3.3V. <b>Note 15</b>		3.2/1.6		mW
1/2 Power Reduction Mode		VBATT = 5.5V/3.3V. <b>Note 16</b>		2.4/1.1		mW
1/4 Power Reduction Mode		VBATT = 5.5V/3.3V. <b>Note 17</b>		1.5/0.7		mW

- (1) Gain defined as overall PGA gain GDTOT = GD1 x GD2 x GD3. Maximum input voltage is given by:  $VIN,MAX = \pm (VREF/2)$  (OSR / OSR+1).
- (2) Offset due to tolerance on *GDoff2* or *GDoff3* setting. For small intrinsic offset, use only *ADC* and *PGA1*.
- (3) Measured with block connected to inputs through Amux block. Normalized input sampling frequency for input impedance is fs = 500 kHz (fs max, worst case). This figure must be multiplied by 2 for fs = 250 kHz, 4 for fs = 125 kHz. Input impedance is proportional to 1/fs.
- (4) Figure independent from gain and sampling frequency. fs. The effective output noise is reduced by the over-sampling ratio
- (5) Resolution is given by  $n = 2 \log_2(OSR) + \log_2(NELCONV)$ . OSR can be set between 8 and 1024, in powers of 2. Nelconv can be set to 1, 2, 4 or 8.
- (6) If a ramp signal is applied to the input, all digital codes appear in the resulting ADC output data.
- (7) Gain error is defined as the amount of deviation between the ideal (theoretical) transfer function and the measured transfer function (with the offset error removed).
- (8) Offset error is defined as the output code error for a zero volt input (ideally, output code = 0). For 1 LSB offset, Nelconv must be at least 2.

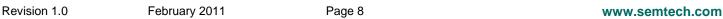


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- INL defined as the deviation of the DC transfer curve of each individual code from the best-fit straight line. This specification holds over the full scale.
- (10)DNL is defined as the difference (in LSB) between the ideal (1 LSB) and measured code transitions for successive codes.
- Values for Gain = 1. PSRR is defined as the amount of change in the ADC output value as the power supply voltage changes. (11)
- (12)Conversion time is given by: TCONV = (NELCONV (OSR + 1) + 1) / fs. OSR can be set between 8 and 1024, in powers of 2. NELCONV can be set to 1,
- PGAs are reset after each writing operation to registers RegACCfg1-5, corresponding to change of configuration or input switching. The (13)ADC should be started only some delay after a change of PGA configuration through these registers. Delay between change of configuration of PGA or input channel switching and ADC start should be equivalent to OSR (between 8 and 1024) number of cycles. This is done by writing bit Start several cycles after PGA settings modification or channel switching. This delay does not apply to conversions made without the PGAs.
- (14)Nominal (maximum) bias currents in PGAs and ADC, i.e. IbAmpPqa[1:0] = '11' and IbAmpAdc[1:0] = '11'.
- Bias currents in PGAs and ADC set to 3/4 of nominal values, i.e. IbAmpPqa[1:0] = '10', IbAmpAdc[1:0] = '10'. (15)
- (16)Bias currents in PGAs and ADC set to 1/2 of nominal values, i.e. IbAmpPqa[1:0] = '01', IbAmpAdc[1:0] = '01'.
- (17)Bias currents in PGAs and ADC set to 1/4 of nominal values, i.e. IbAmpPqa[1:0] = '00', IbAmpAdc[1:0] = '00'.



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#### 2.1 Timing Characteristics

#### Table 5. General timings

Parameter	Symbol	Comment/Condition	Min	Тур	Max	Unit	
ADC INTERRUPT (READY) TIMING SPEC	ADC INTERRUPT (READY) TIMING SPECIFICATIONS						
READY pulse width	tIRQ	Note 18		1		1/fs	
STARTUP TIMES							
Startup sequence time at POR	tstartup			A O M	800	μs	
Time to enable RC from Sleep after a SPI command	trcen			100	450	μs	
Effective Start	tstart_spi			250		μs	

<sup>(18)</sup> The READY pulse indicates End of Conversion. This is a Positive pulse of duration equal to one cycle of the ADC sampling rate in "continuous mode". See also **Figure 15**, **page 30** for data conversion waveforms.

#### 2.1.1 POR Timings

The Slave Select pin  $(\overline{SS})$  can be used to detect the effective start of the device. See **section 9.4**, **page 42** for functional descriptions. The SPI interface can be accessed as soon as the  $\overline{SS}$  pin (slave) is set to 'input' as illustrated on **Figure 2**.

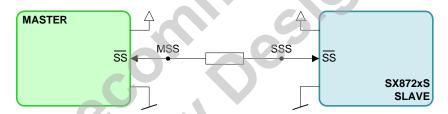


Figure 1. SPI Master detecting start sequence through Slave Select pin

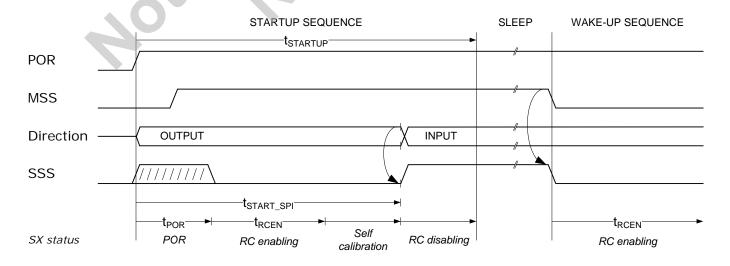


Figure 2. Slave Select pin and Power-On-Reset Timings

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# 2.1.2 SPI interface timings

Parameter	Symbol	Min	Тур	Max	Units
SS to SCLK Edge	tsssc	30			ns
SCLK Period	<b>t</b> sc	500			ns
SCLK Low Pulse width	<b>t</b> scl	200			ns
SCLK High Pulse width	<b>t</b> sch	200		<b>(</b>	ns
Data Output Valid after SCLK Edge	tov		125	200	ns
Data Input Setup Time before SCLK Edge	tos	0	XC		ns
Data Input Hold Time after SCLK Edge	<b>t</b> DH	100	250		ns
SS High after SCLK Edge	tscss	0			ns
SS High to MISO High Impedance	tssp	40		30	ns

# 2.1.3 SPI timing diagram

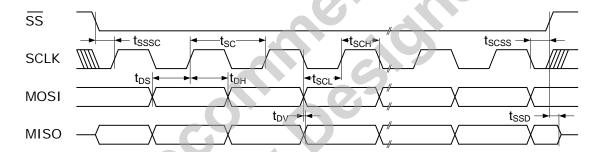


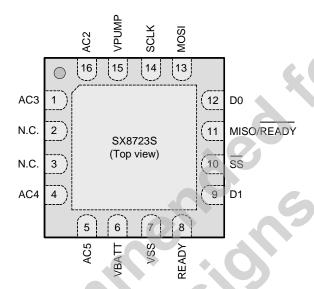
Figure 3. SPI timing diagram

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# **CIRCUIT DESCRIPTION**

# **3 Pin Configuration**



# 4 Marking Information



nnnnn = Part Number yyww = Date Code<sup>1</sup>

xxxxx = Semtech Lot Number

xxxxx

1.Date codes and Lot numbers starting with the 'E' character are used for Engineering samples

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# **5 Pin Description**

Note The bottom pad is internally connected to VSS. It should also be connected to

VSS on PCB to reduce noise and improve thermal behavior.

Pin	Name	Туре	Function
1	AC3	Analog Input	Differential sensor input in conjunction with AC2
2	N.C.	-	Not used
3	N.C.	-	Not used
4	AC4	Analog Input	Differential sensor input in conjunction with AC5
5	AC5	Analog Input	Differential sensor input in conjunction with AC4
6	VBATT	Power Input	2.4V to 5.5V power supply
7	VSS	Power Input	Chip Ground
8	READY	Digital Output	Data Ready (active high). Conversion complete flag.
9	D1	Digital IO	Digital output sensor drive (VBATT or VSS)
9		Analog	VREF Input in optional operating mode
10	SS	Digital Input	Chip select (active low).
11	MISO/READY	Digital Output	Serial data output (Master Input, Slave Output), or data out combined with READY (active low when ADC Data Ready function enabled).
12	D0	Digital IO	Digital output sensor drive (VBATT or VSS)
12	D0	Analog	VREF Output in optional operating mode
13	MOSI	Digital Input	Serial data input (Master Output, Slave Input).
14	SCLK	Digital Input	Serial clock input.
15	VPUMP	Power IO	Charge pump output. Raises ADC supply above VBATT if VBATT supply is too low. Recommended range for capacitor is 1nF to 10 nF. Connect the capacitor to ground.
16	AC2	Analog Input	Differential sensor input in conjunction with AC3

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# **6 General Description**

The SX8723S is a complete low-power acquisition path with programmable gain, acquisition speed and resolution.

### 6.1 Bloc diagram

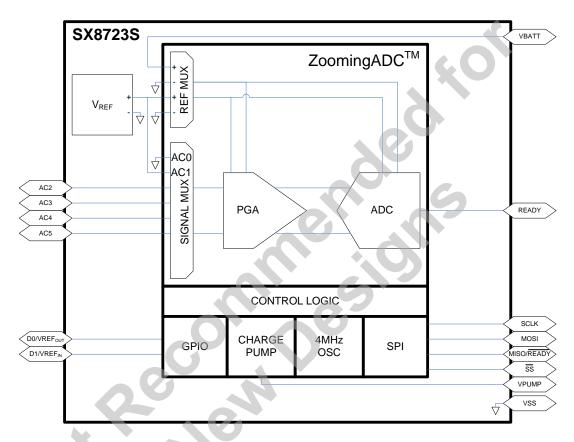


Figure 4. SX8723S bloc diagram

#### **6.2 VREF**

The internally generated *VREF* is a trimmed bandgap reference with a nominal value of 1.22V that provides a stable voltage reference for the *ZoomingADC*.

This reference voltage is directly connected to one of the ZoomingADC reference multiplexer inputs.

The bandgap voltage stability is only guaranteed for *VBATT* voltages of 3V and above. As *VBATT* drops down to 2.4V, the bandgap voltage could reduce by up to 50mV.

The bandgap has relatively weak output drive so it is recommended that if the bandgap is required as a signal input then *PGA1* must be enabled with gain = 1.

#### **6.3 GPIO**

The GPIO block is a multipurpose 2 bit input/output port. In addition to digital behavior, D0 and D1 pins can be programmed as analog pins in order to be used as output (reference voltage monitoring) and input for an external



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reference voltage (For further details see **Figure 7**, **Figure 8**, **Figure 9** and **Figure 10**). Each port terminal can be individually selected as digital input or output.

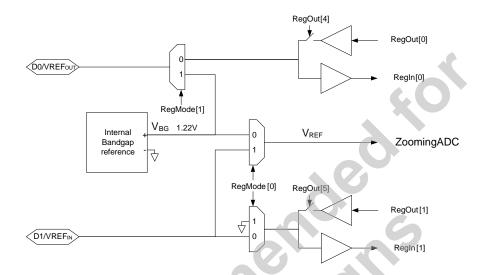


Figure 5. GPIO bloc diagram

The direction of each bit within the *GPIO* block (input only or input/output) can be individually set using the bits of the **RegOut** (address 0x40) register. If D[x]Dir = 1, both the input and output buffer are active on the corresponding *GPIO* block pin. If D[x]Dir = 0, the corresponding *GPIO* block pin is an input only and the output buffer is in high impedance. After power on reset the GPIO block pins are in input/output mode (D[x]Dir are reset to 1).

The input values of *GPIO* block are available in **RegIn** (address 0x41) register (read only). Reading is always direct - there is no debounce function in the *GPIO* block. In case of possible noise on input signals, an external hardware filter has to be realized. The input buffer is also active when the *GPIO* block is defined as output and the effective value on the pin can be read back.

Data stored in the LSB bits of **RegOut** register are outputted at *GPIO* block if D[x]Dir = 1. The default values after power on reset is low (0).

The digital pins are able to deliver a driving current up to 8 mA.

When the bits *VrefD0Out* and *VrefD1In* in the **RegMode** (address 0x70) register are set to 1 the *D0* and *D1* pins digital behavior are automatically bypassed in order to either input or output the voltage reference signals.

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#### 6.3.1 Optional Operating Mode: External Vref

*D0* and *D1* are multi-functional pins with the following functions in different operating modes (see **RegMode** register for control settings):

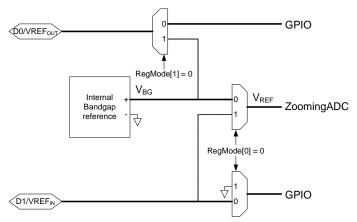


Figure 7. D0 and D1 are Digital Inputs / Outputs

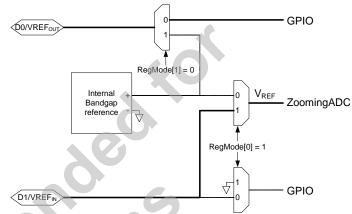


Figure 8. D1 is Reference Voltage Input and D0 is Digital Input / Output

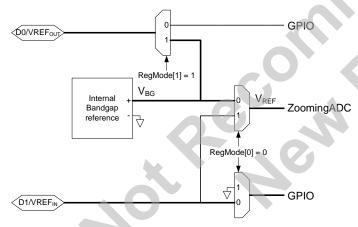


Figure 9. D1 is Digital Input / Output and D0 Reference
Voltage Output

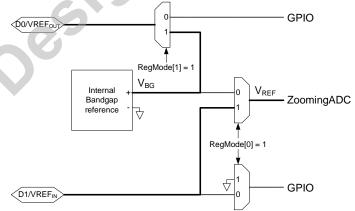


Figure 10. D0 is Reference Voltage Output and D1 is Reference Voltage Input

This allows external monitoring of the internal bandgap reference or the ability to use an external reference input for the ADC, or the option to filter the internal VREF output before feeding back as VREF,ADC input. The internally generated VREF is a trimmed as ADC reference with a nominal value of 1.22V. When using an external VREF,ADC input, it may have any value between 0V and VBATT. Simply substitute the external value for 1.22 V in the ADC conversion calculations.



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#### 6.4 Charge Pump

This block generates a supply voltage able to power the analog switch drive levels on the chip higher than VBATT if necessary.

If VBATT voltage drops below 3V then the block should be activated. If VBATT voltage is greater than 3V then VBATT may be switched straight through to the VPUMP output. If the charge pump is not activated then VPUMP = VBATT.

If control input bit MultForceOff = 1 in **RegMode** (address 0x70) register then the charge pump is disabled and VBATT is permanently connected to VPUMP output.

If control input bit *MultForceOn* = 1 in **RegMode** register then the charge pump is permanently enabled. This overrides *MultForceOff* bit in **RegMode** register.

An external capacitor is required on *VPUMP* pin. This capacitor should be large enough to ensure that generated voltage is smooth enough to avoid affecting conversion accuracy but not so large that it gives an unacceptable settling time. A recommended value is around 2.2nF.

#### 6.5 RC Oscillator

This block provides the master clock reference for the chip. It produces a clock at 4 MHz which is divided internally in order to generate the clock sources needed by the other blocks.

The oscillator technique is a low power relaxation design and it is designed to vary as little as possible over temperature and supply voltage.

This oscillator is trimmed at manufacture chip test.

The RC oscillator will start up after a chip reset to allow the trimming values to be read and calibration registers. Once this has been done, the oscillator will be shut down and the chip will enter a sleep state while waiting for a SPI communication.

The worst case duration from reset (or POR) to the sleep state is 800us.

#### 6.5.1 Wake-up from sleep

When the device is in sleep state, the RC oscillator will start up after a communication. The start up sequence for the RC oscillator is 450us in worst case.

During this time, the internal blocs using the RC can not be used: no ADC conversion can be started.

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# 7 ZoomingADC

#### 7.1 Overview

The *ZoomingADC* is a complete and versatile low-power analog front-end interface typically intended for sensing applications. In the following text the *ZoomingADC* will be referred as *ZADC*.

The key features of the ZADC are:

- Programmable 6 to 16-bit dynamic range over-sampled ADC
- Flexible gain programming between 1/12 and 1000
- Flexible and large range offset compensation
- Differential or single-ended input
- 2-channel differential reference inputs
- Power saving modes

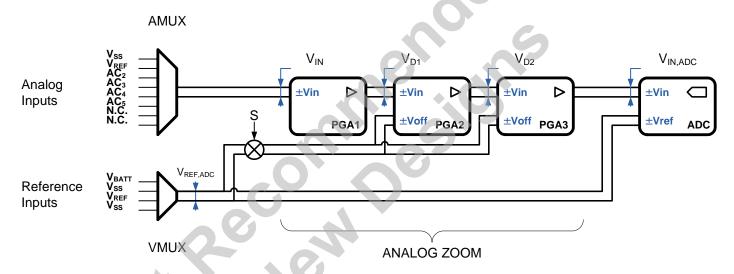


Figure 11. ZADC General Functional Block Diagram

The total acquisition chain consists of an input multiplexer, 3 programmable gain amplifier stages and an over sampled A/D converter. The reference voltage can be selected on two different channels. Two offset compensation amplifiers allow for a wide offset compensation range. The programmable gain and offset allow the application to zoom in on a small portion of the reference voltage defined input range.

#### 7.1.1 Acquisition Chain

**Figure 11, page 17** shows the general block diagram of the acquisition chain (*AC*). A control block (not shown in **Figure 11**) manages all communications with the SPI peripheral. The clocking is derived from the internal 4 MHz Oscillator.

Analog inputs can be selected through an 8 input multiplexer, while reference input is selected between two differential channels. It should however be noted that only 7 acquisition channels (including the VREF) are available when configured as single ended since the input amplifier is always operating in differential mode with both positive and negative input selected through the multiplexer.

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The core of the zooming section is made of three differential programmable amplifiers (PGA). After selection of an input and reference signals VIN and VREF,ADC combination, the input voltage is modulated and amplified through stages 1 to 3. Fine gain programming up to 1'000 V/V is possible. In addition, the last two stages provide programmable offset. Each amplifier can be bypassed if needed.

The output of the cascade of PGA is directly fed to the analog-to-digital converter (ADC), which converts the signal VIN, ADC into digital.

Like most ADCs intended for instrumentation or sensing applications, the ZoomingADC<sup>TM</sup> is an over-sampled converter <sup>1</sup>. The ADC is a so-called incremental converter; with bipolar operation (the ADC accepts both positive and negative differential input voltages). In first approximation, the ADC output result relative to full-scale (FS) delivers the quantity:

$$\frac{OUT_{ADC}}{FS/2} \cong \frac{V_{IN,ADC}}{V_{REF}/2}$$

in two's complement (see Equation 18 and Equation 19, page 30 for details). The output code OUTADC is -FS / 2 to + FS/2 for VIN,ADC = -VREF,ADC / 2 to + VREF,ADC / 2 respectively. As will be shown, VIN,ADC is related to input voltage VIN by the relationship:

$$V_{IN,ADC} = GD_{TOT} \cdot V_{IN} - GDoff_{TOT} \cdot S \cdot V_{REF}$$
 [V]  
Equation 2

where GDTOT is the total PGA gain, GDOFFTOT is the total magnitude of PGA offset and S is the sign of the offset (see **Table 8, page 21).** 

#### 7.1.2 Programmable Gain Amplifiers

As seen in Figure 11, page 17, the zooming function is implemented with three programmable gain amplifiers (PGA). These are:

- *PGA1*: coarse gain tuning
- PGA2: medium gain and offset tuning
- PGA3: fine gain and offset tuning. Should be set ON for high linearity data acquisition

All gain and offset settings are realized with ratios of capacitors. The user has control over each PGA activation and gain, as well as the offset of stages 2 and 3. These functions are examined hereafter.

Over-sampled converters are operated with a sampling frequency fs much higher than the input signal's Nyquist rate (typically fs is 20-1. 1'000 times the input signal bandwidth). The sampling frequency to throughput ratio is large (typically 10-500). These converters include digital decimation filtering. They are mainly used for high resolution, and/or low-to-medium speed applications.

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#### 7.1.3 PGA & ADC Enabling

Depending on the application objectives, the user may enable or bypass each *PGA* stage. This is done according to the word *Enable* and the coding given in **Table 6**. To reduce power dissipation, the *ADC* can also be inactivated while idle.

**Table 6. ADC and PGA Enabling** 

Enable (RegACCfg1[3:0])	Block
XXX0	ADC disabled
XXX1	ADC enabled
XX0X	PGA1 disabled
XX1X	PGA1 enabled
X0XX	PGA2 disabled
X1XX	PGA2 enabled
0XXX	PGA3 disabled
1XXX	PGA3 enabled

### 7.2 ZoomingADC Registers

The system has a bank of eight 8-bit registers: six registers are used to configure the acquisition chain (**RegAcCfg0** to **RegAcCfg5**), and two registers are used to store the output code of the analog-to-digital conversion (**RegAcOutMsb** & **Lsb**).

Table 7. Registers to Configure the Acquisition Chain (AC) and to Store the Analog-to-Digital Conversion (ADC) Result

Register	Bit position		70					
Name	7	6	5	4	3	2	1	0
RegACOutLsb	Out[7:0] Note 1							
RegACOutMs b	utMs <i>Out</i> [15:8]							
RegACCfg0 Default values:	Start 0, Note 2		elconv ote 3		Set0 010, <b>N</b>		Continuous 0, <b>Note 5</b>	SampleShiftEn 0, <b>Note 6</b>
RegACCfg1 Default value:		pAdc ote 7		npPga lote 8			Enable 0000, <b>Note 9</b>	•
RegACCfg2 Default value:	Se 00, <b>N</b> o	tFs ote 10	<i>Pga2Gain</i> 00, <b>Note 12</b>		(	Pga2Offset 0000, <b>Note 14</b>		
RegACCfg3 Default value:	Pga1Gain 0, <b>Note 11</b>	<i>Pga3Gain</i> 0001100, <b>Note 13</b>						
RegACCfg4 Default value:	DataReadyEn 0, Note 15	<i>Pga3Offset</i> 0000000, <b>Note 16</b>						
RegACCfg5 Default value:	Busy 0, <b>Note 17</b>	Def 0, <b>Note 18</b>			Am 00000, N			<i>Vmux</i> 0, <b>Note 20</b>

(r = read; w = write; rw = read & write)

<sup>(1)</sup> **Out**: (r) digital output code of the analog-to-digital converter. (MSB = Out[15])

<sup>(2)</sup> **Start**: (w) setting this bit triggers a single conversion (after the current one is finished). This bit always reads back 0.

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- (3) **SetNelconv**: (rw) sets the number of elementary conversions to 2<sup>(SetNelconv[1:0])</sup>. To compensate for offsets, the input signal is chopped between elementary conversions (1,2,4,8).
- (4) **SetOsr**: (rw) sets the over-sampling rate (*OSR*) of an elementary conversion to  $2^{(3+SetOsr[2:0])}$ . *OSR* = 8, 16, 32, ..., 512, 1024.
- (5) **Continuous**: (rw) setting this bit starts a conversion. When this bis is 1, A new conversion will automatically begin directly when the previous one is finished.
- (6) SampleShiftEn: (rw) the 16-bit samples can be directly shifted out though the SPI interface by the master when a conversion is done.
- (7) **IbAmpAdc**: (rw) sets the bias current in the *ADC* to 0.25 x (1+ *IbAmpAdc*[1:0]) of the normal operation current (25, 50, 75 or 100% of nominal current). To be used for low-power, low-speed operation.
- (8) **IbAmpPga:** (rw) sets the bias current in the PGAs to 0.25 x (1+*IbAmpPga[1:0]*) of the normal operation current (25, 50, 75 or 100% of nominal current). To be used for low-power, low-speed operation.
- (9) **Enable**: (rw) enables the ADC modulator (bit 0) and the different stages of the PGAs (PGAi by bit i=1,2,3). PGA stages that are disabled are bypassed.
- (10) **SetFs**: (rw) These bits set the over sampling frequency of the acquisition chain. Expressed as a fraction of the oscillator frequency, the sampling frequency is given as: 11 ' 500 kHz, 10 ' 250 kHz, 01 ' 125 kHz, 00 ' 62.5 kHz.
- (11) **Pga1Gain**: (rw) sets the gain of the first stage: 0 ' 1, 1 ' 10.
- (12) **Pga2Gain**: (rw) sets the gain of the second stage: 00 ' 1, 01 ' 2, 10 ' 5, 11 ' 10.
- (13) **Pga3Gain**: (rw) sets the gain of the third stage to *Pga3Gain*[6:0] 1/12.
- (14) **Pga2Offset**: (rw) sets the offset of the second stage between -1 and +1, with increments of 0.2. The *MSB* gives the sign (0 positive, 1 negative); amplitude is coded with the bits *Pga2Offset*[5:0].
- (15) **DataReadyEn:** (rw) enables the combined data ready mode with the MISO of the SPI interface.
- (16) **Pga3Offset**: (rw) sets the offset of the third stage between -5.25 and +5.25, with increments of 1/12. The *MSB* gives the sign (0 positive, 1 negative); amplitude is coded with the bits *Pga3Offset*[5:0].
- (17) **Busy**: (r) set to 1 if a conversion is running.
- (18) **Def**: (w) sets all values to their defaults (PGA disabled, *AMux* not changed, *VMux* not changed, *ADC* enabled, nominal modulator bias current (100%), 2 elementary conversions, *OSR* = 32, *Nelconv* = 2, *fs* = 62.5kHz) and starts a new conversion without waiting the end of the preceding one.
- (19) **Amux**(4:0): (rw) Amux[4] sets the mode (0 ' differential inputs, 1 ' single ended inputs with A0= common reference) Amux[3] sets the sign (0 ' straight, 1' cross) Amux[2:0] sets the channel.
- (20) **Vmux**: (rw) sets the differential reference channel (0 ' VBATT 1 ' VREF).

### 7.3 Input Multiplexers (AMUX and VMUX)

The ZoomingADC has analog inputs ACO to AC5 and reference inputs. Let us first define the differential input voltage VIN and reference voltage VREF,ADC respectively as:

$$V_{IN} = V_{INP} - V_{INN} \qquad [V]$$

**Equation 3** 

$$V_{RFF} = V_{RFFP} - V_{RFFN} \qquad [V]$$

**Equation 4** 



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As shown in **Table 8**, the inputs can be configured in two ways: either as 4 differential channels (VIN1 = AC1 - AC0,..., VIN3 = AC5 - AC4), or AC0 can be used as a common reference, providing 7 signal paths all referred to AC0. The control word for the analog input selection is Amux. Notice that the Amux bit 4 controls the sign of the input voltage.

**Table 8. Analog Input Selection** 

Amux (RegACCfg5[5:1])	VINP	VINN
Sign S = 1		
00x00	AC1(VREF)	AC0(Vss)
00x01	AC3	AC2
00x10	AC5	AC4
00x11	N.C.	N.C.
10000	AC0(Vss)	
10001	AC1(VREF)	
10010	AC2	]
10011	AC3	AC0(Vss)
10100	AC4	ACO(V33)
10101	AC5	
10110	N.C.	
10111	N.C.	

Amux (RegACCfg5[5:1])	VINP	Vinn
Sign S = -1		
01x00	AC1(Vss)	AC0(VREF)
01x01	AC2	AC3
01x10	AC4	AC5
01x11	N.C.	N.C.
11000		AC0(Vss)
11001		AC1(VREF)
11010	AC0(Vss)	AC2
11011		AC3
11100		AC4
11101		AC5
11110		N.C.
11111		N.C.

Similarly, the reference voltage is chosen among two differential channels (VREF = VBATT-VSS, VREF = VBG-VSS or VREF = VREF,IN-VSS) as shown in **Table 9**. The selection bit is Vmux. The reference inputs VREFP and VREFN (common-mode) can be up to the power supply range.

**Table 9. Analog reference Input Selection** 

Vmux (RegACCfg5[0])	VREFP	Vrefn
0	VREF = VBATT	Vss
1	$V_{REF} = V_{BG} \text{ or } V_{REF,IN}^{1}$	Vss

<sup>1.</sup> External voltage reference on D1 GPIO pin. See **section 6.3 on page 13** about GPIO and "RegMode[0x70]" on page 47.

#### 7.4 First Stage Programmable Gain Amplifier (PGA1)

The first stage can have a buffer function (unity gain) or provide a gain of 10 (see **Table 10**). The voltage *VD1* at the output of *PGA1* is:

$$V_{D1} = GD_1 \cdot V_{IN} \qquad [V]$$

**Equation 5** 

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where GD1 is the gain of PGA1 (in V/V) controlled with the Pga1Gain bit.

Table 10. PGA1 gain settings

Pga1Gain bit (RegACCfg3[7])	PGA1 gain [V/V] GD1 [V/V]
0	1
1	10

# 7.5 Second Stage Programmable Gain Amplifier (PGA2)

The second *PGA* has a finer gain and offset tuning capability, as shown in **Table 11**. The *VD2* voltage at the output of *PGA2* is given by:

$$V_{D2} = GD_2 \cdot V_{D1} - GDoff_2 \cdot S \cdot V_{REF} \quad [V]$$

#### Equation 6

where GD2 and GDOFF2 are respectively the gain and offset of PGA2 (in V/V). These are controlled with the words Pga2Gain[1:0] and Pga2Offset[3:0].

Table 11. PGA2 gain and offset settings

Pga2Gain bit field (RegACCfg2[5:4])	PGA2 gain [V/V] GD2 [V/V]
00	1
01	2
10	5
11	10

Pga2Offset bit field (RegACCfg2[3:0])	PGA2 offset GDOFF2 [V/V]
0000	0
0001	+0.2
0010	+0.4
0011	+0.6
0100	+0.8
0101	+1
1000	0
1001	-0.2
1010	-0.4
1011	-0.6
1100	-0.8
1101	-1.0

# 7.6 Third Stage Programmable Gain Amplifier (PGA3)

The finest gain and offset tuning is performed with the third and last PGA stage, according to the coding of Table 12.

**Table 12. PGA3 Gain and Offset Settings** 

Pga3Gain bit field (RegACCfg3[6:0])	PGA3 Gain GD₃ [V/V]
0000000	0
0000001	1/12 (=0.083)

Pga3Offset bit field (RegACCfg4[6:0])	PGA3 Offset GDOFF3 [V/V]
0000000	0
000001	+1/12 (=0.083)

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**Table 12. PGA3 Gain and Offset Settings** 

Pga3Gain bit field (RegACCfg3[6:0])	PGA3 Gain GD3 [V/V]
0000110	6/12
0001100	12/12
0010000	16/12
0100000	32/12
1000000	64/12
1111111	127/12 (=10.58)

Pga3Offset bit field (RegACCfg4[6:0])	PGA3 Offset GDOFF3 [V/V]
0010000	+16/12
0100000	32/12
0111111	+63/12 (=+5.25)
1000000	0
1000001	-1/12 (=-0.083)
1000010	-2/12
1010000	-16/12
<i>"</i> .	<b>6</b> 0
1100000	-32/12
- A	
1111111	-63/12 (=-5.25)

The output of *PGA3* is also the input of the *ADC*. Thus, similarly to *PGA2*, we find that the voltage entering the *ADC* is given by:

$$V_{IN,ADC} = GD_3 \cdot V_{D2} - GDoff_3 \cdot S \cdot V_{REF}$$
 [V]

#### **Equation 7**

where GD3 and GDOFF3 are respectively the gain and offset of PGA3 (in V/V). The control words are Pga3Gain[6:0] and Pga3Offset[6:0].

To remain within the signal compliance of the PGA stages (no saturation), the condition:

$$\left|V_{IN}\right|, \left|V_{D1}\right|, \left|V_{D2}\right| < \frac{V_{BATT}}{2}$$

#### **Equation 8**

must be verified.

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To remain within the signal compliance of the ADC (no saturation), the condition:

$$\left|V_{IN,ADC}\right| < \left(\frac{V_{REF}}{2}\right) \left(\frac{OSR - 1}{OSR}\right)$$

#### **Equation 9**

must be verified.

Finally, combining **Equation 5** to **Equation 7** for the three *PGA* stages, the input voltage *VIN,ADC* of the *ADC* is related to *VIN* by:

$$V_{IN,ADC} = GD_{TOT} \cdot V_{IN} - GDoff_{TOT} \cdot S \cdot V_{REF}$$
 [V]

**Equation 10** 

where the total PGA gain is defined as:

$$GD_{TOT} = GD_3 \cdot GD_2 \cdot GD$$

**Equation 11** 

and the total PGA offset is:

$$GDoff_{TOT} = GDoff_3 + GD_3 \cdot GDoff_2$$

**Equation 12** 

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#### 7.7 Analog-to-Digital Converter (ADC)

The main performance characteristics of the ADC (resolution, conversion time, etc.) are determined by three programmable parameters. The setting of these parameters and the resulting performances are described later.

fs: Over-sampling frequency OSR: Over-Sampling Ratio

**NELCONV: Number of Elementary Conversions** 

#### 7.7.1 Conversion Sequence

A conversion is started each time the bit Start or the Def bit is set. As depicted in Figure 12, a complete analog-todigital conversion sequence is made of a set of NELCONV elementary incremental conversions and a final quantization step. Each elementary conversion is made of (OSR+1) over-sampling periods Ts=1/fs, i.e.:

$$T_{ELCONV} = (OSR+1)/f_S$$
 [s]
Equation 13

The result is the mean of the elementary conversion results. An important feature is that the elementary conversions are alternatively performed with the offset of the internal amplifiers contributing in one direction and the other to the output code. Thus, converter internal offset is eliminated if at least two elementary sequences are performed (i.e. if NELCONV >= 2). A few additional clock cycles are also required to initiate and end the conversion properly.

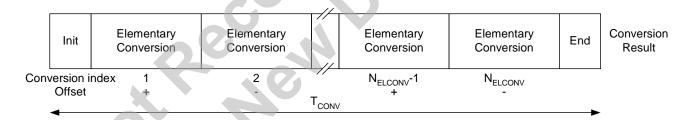


Figure 12. Analog-to-Digital Conversion Sequence

Note

The internal bandgap reference state may be forced High or Low, or may be set to toggle during conversion at either the same rate or half the rate of the Elementary Conversion. This may be useful to help eliminate bandgap related internal offset voltage and 1/fs noise.

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#### 7.7.2 Over-Sampling Frequency (fs)

The word SetFs[1:0] (see **Table 13**) is used to select the over-sampling frequency fs. The over-sampling frequency is derived from the 4MHz oscillator clock.

**Table 13. Sampling frequency settings** 

SetFs bit field (RegACCfg2[7:6])	Over-Sampling Frequency fs [Hz]	
00	62.5 kHz	
01	125 kHz	
10	250 kHz	
11	500 kHz	

#### 7.7.3 Over-Sampling Ratio (OSR)

The over-sampling ratio (OSR) defines the number of integration cycles per elementary conversion. Its value is set with the word SetOsr[2:0] in power of 2 steps (see **Table 14**) given by:

$$OSR = 2^{3 + SetOsr[2:0]}$$
 [-

**Equation 14** 

**Table 14. Over-sampling ratio settings** 

SetOsr[2:0] (RegACCfg[4:2])	Over-Sampling Ratio OSR [-]
000	8
001	16
010	32
011	64
100	128
101	256
110	512
111	1024

#### 7.7.4 Number of Elementary Conversions (Nelconv)

As mentioned previously, the whole conversion sequence is made of a set of *NELCONV* elementary incremental conversions. This number is set with the word *SetNelconv*[1:0] in power of 2 steps (see **Table 15**) given by:

$$N_{ELCONV} = 2^{\text{SetNelconv}[1:0]}$$
 [-]

**Equation 15** 

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**Table 15. Number of elementary conversion** 

SetOsr[2:0] (RegACCfg[4:2])	# of Elementary Conversion NELCONV [-]	
00	1	
01	2	
10	4	
11	8	

As already mentioned, NELCONV must be equal or greater than 2 to reduce internal amplifier offsets.

#### 7.7.5 Resolution

The theoretical resolution of the ADC, without considering thermal noise, is given by:

$$n = 2 \cdot \log_2(OSR) + \log_2(N_{ELCONV}) \quad [bit]$$

#### **Equation 16**

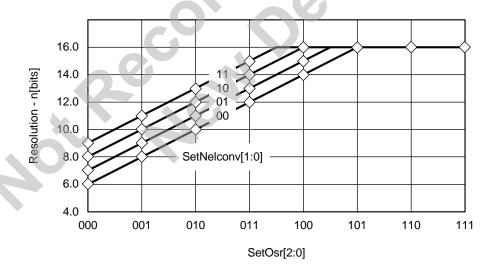


Figure 13. Resolution vs. SetOsr[2:0] and SetNelconv[2:0]

Using look-up **Table 16** or the graph plotted in **Figure 13**, resolution can be set between 6 and 16 bits. Notice that, because of 16-bit register use for the *ADC* output, **practical resolution is limited to 16 bits**, i.e. n = 16. Even if the

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resolution is truncated to 16 bit by the output register size, it may make sense to set OSR and  $N_{ELCONV}$  to higher values in order to reduce the influence of the thermal noise in the PGA.

Table 16. Resolution 1 vs. SetOsr and SetNelconv settings

SetOsr	SetNelconv	SetNelconv control bits			
control bits	<b>'00'</b>	<b>'01'</b>	'10'	'11'	
<b>'000'</b>	6	7	8	9	
<b>'001'</b>	8	9	10	11	
<b>'010'</b>	10	11	12	13	
<b>'011'</b>	12	13	14	15	
<b>'100'</b>	14	15	16	16	
<b>'101'</b>	16	16	16	16	
<b>'110'</b>	16	16	16	16	
<b>'111'</b>	16	16	16	16	

<sup>1.</sup> In shaded area, the resolution is truncated to 16 bits due to output register size **RegA-COut[15:0]** 

#### 7.7.6 Conversion Time & Throughput

As explained in Figure 13, conversion time is given by:

$$T_{CONV} = (N_{ELCONV} \cdot (OSR+1)+1)/f_S$$
 [s]

#### Equation 17

and throughput is then simply  $1/T_{CONV}$ . For example, consider an over-sampling ratio of 256, 2 elementary conversions, and a sampling frequency of 500 kHz (SetOsr = "101", SetNelconv = "01" and SetFs = "00"). In this case, using **Table 17**, the conversion time is 515 sampling periods, or 1.03ms. This corresponds to a throughput of 971Hz in continuous-time mode. The plot of **Figure 14** illustrates the classic trade-off between resolution and conversion time.

Table 17. Normalized conversion time (Tconv x fs) vs. SetOsr and SetNelconv settings<sup>1</sup>

SetOsr bits	SetNelconv control bits NELCONV			
OSR	'00' 1	'01' 2	'10' 4	'11' 8
'000'	10	19	37	73
'001'	18	35	69	137
'010'	34	67	133	265
'011'	66	131	261	521

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Table 17. Normalized conversion time (Tconv x fs) vs. SetOsr and SetNelconv settings<sup>1</sup>

SetOsr bits	SetNelconv control bits NELCONV			
OSR	'00' 1	'01' 2	'10' 4	'11' 8
'100'	130	259	517	1033
'101'	258	515	1029	2057
'110'	514	1027	2053	4105
'111'	1026	2051	4101	8201

<sup>1.</sup> Normalized to sampling period 1/fs

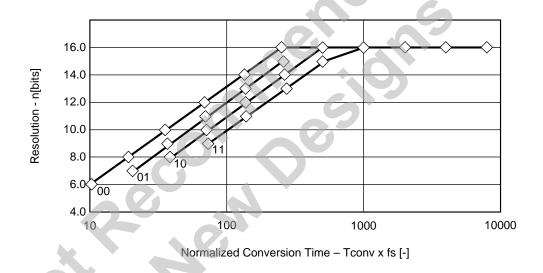


Figure 14. Resolution vs. normalized<sup>1</sup> conversion time for different SetNelconv[1:0]

1. Normalized Conversion Time - TCONV x fs

# 7.7.7 Continuous-Time vs. On-Request Conversion

The ADC can be operated in two distinct modes: "continuous-time" and "on-request" modes (selected using the bit Continuous).

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In "continuous-time" mode, the input signal is repeatedly converted into digital. After a conversion is finished, a new one is automatically initiated. The new value is then written in the result register, and the corresponding internal trigger pulse is generated. This operation is sketched in **Figure 15**. The conversion time in this case is defined as *TCONV*.

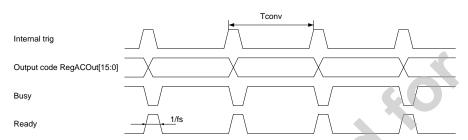


Figure 15. ADC "Continuous-Time" Operation

In the "on-request" mode, the internal behavior of the converter is the same as in the "continuous-time" mode, but the conversion is initiated on user request (with the *Start* bit). As shown in **Figure 16**, the conversion time is also *TCONV*.

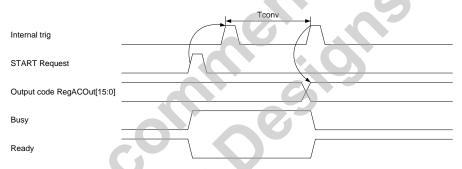


Figure 16. ADC "On-Request" Operation

#### 7.7.8 Output Code Format

The ADC output code is a 16-bit word in two's complement format (see **Table 18**). For input voltages outside the range, the output code is saturated to the closest full-scale value (i.e. 0x7FFF or 0x8000). For resolutions smaller than 16 bits, the non-significant bits are forced to the values shown in **Table 19**. The output code, expressed in *LSBs*, corresponds to:

$$OUT_{ADC} = 2^{16} \cdot \frac{V_{IN,ADC}}{V_{RFF}} \cdot \frac{OSR + 1}{OSR}$$

#### **Equation 18**

Recalling **Equation 10**, page 24, this can be rewritten as:

$$OUT_{ADC} = 2^{16} \cdot \frac{V_{IN}}{V_{REF}} \cdot \left( GD_{TOT} - GDoff_{TOT} \cdot S \cdot \frac{V_{REF}}{V_{IN}} \right) \cdot \frac{OSR + 1}{OSR} \quad [LSB]$$

#### **Equation 19**



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where, from **Equation 11** and **Equation 12**, the total *PGA* gain and offset are respectively:

$$GD_{TOT} = GD_3 \cdot GD_2 \cdot GD_1$$

**Equation 20** 

and:

$$GDoff_{TOT} = GDoff_3 + GD_3 \cdot GDoff_2$$

# **Equation 21**

Table 18. Basic ADC Relationships (example for: VREF = 5V, OSR = 512, n = 16bits)

ADC Input Voltage V <sub>IN,ADC</sub>	% of Full Scale (FS)	Output in LSBs	Hexadecimal Output Code
+2.49505 V	+0.5 x FS	+2 <sup>15</sup> -1 = 32′767	7FFF
+2.49497 V		$+2^{15}-2=32'766$	7FFE
+76.145 μV		+1	0001
0	0	0	0000
-76.145 μV		-1	FFFF
		\	
-2.49505 V		-2 <sup>15</sup> -1 = -32′767	8001
-2.49513 V	-0.5 x FS	-2 <sup>15</sup> = -32′768	8000

Table 19. Last forced LSBs in conversion output register for resolution settings smaller than 16bits 1

SetOsr[2:0]	SetNelconv = '00'	SetNelconv = '01'	SetNelconv = '10'	SetNelconv = '11'
'000'	100000000	100000000	10000000	1000000
'001'	10000000	1000000	100000	10000
'010'	100000	10000	1000	100
'011'	1000	100	10	1
'100'	10	1	-	-
'101'	-	-	-	-
'110'	-	-	-	-
'111'	-	-	-	-

<sup>1. (</sup>n<16) (RegACOutMsb[7:0] & RegACOutLsb[7:0])

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The equivalent LSB size at the input of the PGA chain is:

$$LSB = \frac{1}{2^{n}} \cdot \frac{V_{REF}}{GD_{TOT}} \cdot \frac{OSR}{OSR + 1} \quad [V/V]$$

#### **Equation 22**

Notice that the input voltage  $V_{IN,ADC}$  of the ADC must satisfy the condition:

$$\left|V_{IN,ADC}\right| \le \frac{1}{2} \cdot \left(V_{REFP} - V_{REFN}\right) \cdot \frac{OSR}{OSR + 1}$$

#### Equation 23

to remain within the ADC input range.

#### 7.7.9 Power Saving Modes

During low-speed operation, the bias current in the *PGAs* and *ADC* can be programmed to save power using the control words *IbAmpPga[1:0]* and *IbAmpAdc[1:0]* (see **Table 20**). If the system is idle, the *PGAs* and *ADC* can even be disabled, thus, reducing power consumption to its minimum. This can considerably improve battery lifetime.

Table 20. ADC & PGA power saving modes and maximum sampling frequency

IbAmpAdc [1:0]	lbAmpPga [1:0]	ADC Bias Current	PGA Bias Current	Max. fs [kHz]
00 01 11	0	1/4 x ladc 1/2 x ladc ladc		125 250 500
	00 01 11		1/4 x IPGA 1/2 x IPGA IPGA	125 250 500



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# 8 Application hints

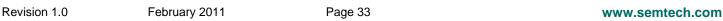
#### **8.1 Power Reduction**

The ZoomingADC is particularly well suited for low-power applications. When very low power consumption is of primary concern, such as in battery operated systems, several parameters can be used to reduce power consumption as follows:

- Operate the acquisition chain with a reduced supply voltage VBATT.
- Disable the PGAs which are not used during analog-to-digital conversion with Enable[3:0].

- Disable all PGAs and the ADC when the system is idle and no conversion is performed.
- Use lower bias currents in the PGAs and the ADC using the control words IbAmpPga[1:0] and IbAmpAdc[1:0].
- Reduce sampling frequency.

Finally, remember that power reduction is typically traded off with reduced linearity, larger noise and slower maximum sampling speed.



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# **8.2 Gain Configuration Flow**

The diagram below shows the flow to set the gain of your configuration:

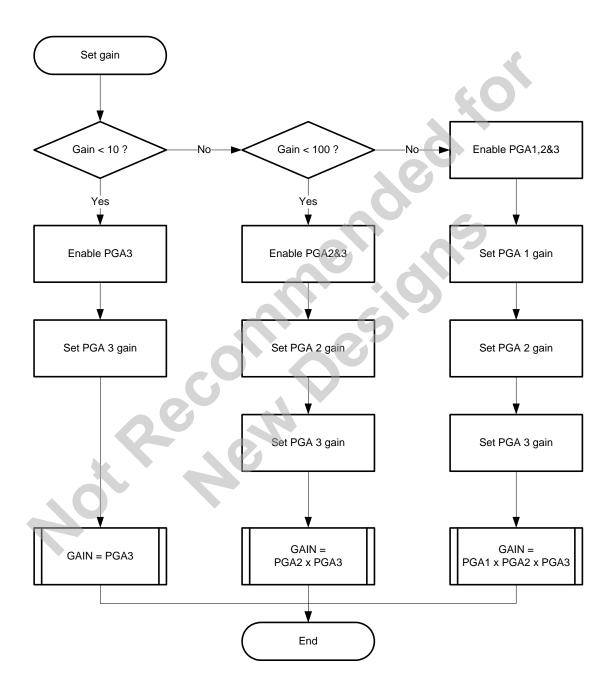


Figure 17. Gain configuration flowchart

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#### 9 SPI interface

#### 9.1 Overview

The SX8723S serial port interface implements the following:

- 4-pin Interface + options for synchronization to ADC sample ready
- 7-bit Target Address (max 128 registers)
- 2 Mbps serial clock
- MSB first

The serial interface is a slave port for communication with a serial microprocessor bus, allowing the SX8723S to be controlled by an external processor. The serial interface header must be connected to the host processor, which acts as the master.

The serial interface signals are:

■ SCLK: Serial Clock

 $\overline{SS}$ : Active low **S**lave **S**elect

MISO/READY: Master Input, Slave Output (data out) and optional active low ADC data Ready signal.

■ *MOSI*: Master Output, Slave Input.

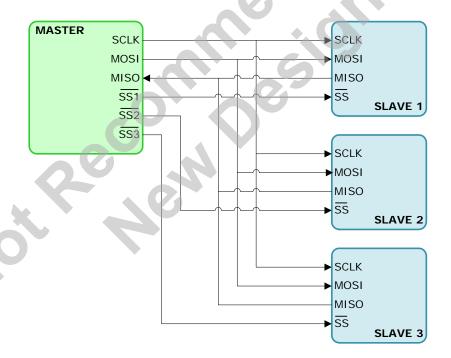


Figure 18. Example of SPI bus with 1 master and 3 slaves

The address and data are transmitted and received MSB first. Valid read/write accesses are possible only when  $\overline{SS}$  is active. MISO and MOSI lines are push-pull pads. As the waveforms illustrate (see below), the slave interface implements a 16-bit shift register. The SPI implemented on the SX8723S is set to the common setting CPOL=0 and CPHA=0 which means data are sampled on the rising edge of the clock, and shifted on the falling one.

The first bit in the serial data is the Direction Bit. This must be set to '1' for reading, and '0' for writing. The following 7 bits represent the target register address, shifted in MSB first. The next byte represents register data, shifted in/out MSB first.



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#### 9.2 Data transmission

#### 9.2.1 Write a single register

To write to a register, the Host must provide the following:

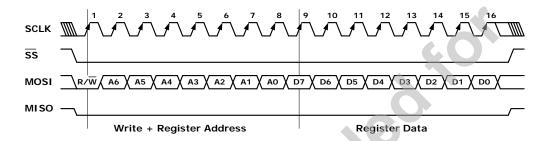


Figure 19. SPI waveform - Write a single register

#### 9.2.2 Read a single register

To read a register from the memory map, the Host must provide the following:

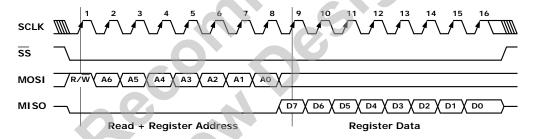


Figure 20. SPI waveform - Read a single register

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#### 9.2.3 Multiple Bytes Write/Read Protocol

The SPI protocol is designed to be able to do multiple read/write during a transaction. During one single operation, as long as Slave Select  $(\overline{SS})$  stay asserted, the register address is automatically increased to allow sequential read/write (or sequential retrieval of data). The register address will be auto-incremented in multiple read/write commands. Between each different operation though the communication should be restarted.

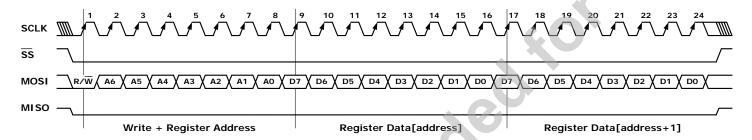


Figure 21. SPI waveform - Multiple bytes SPI Write protocol (2 bytes example)

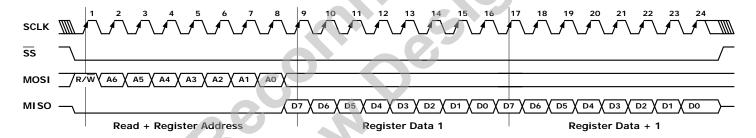


Figure 22. SPI waveform - Multiple bytes SPI Read protocol (2 bytes example)

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#### 9.3 ADC Samples Reading

- The default SPI mode the ADC samples must be read with the default SPI read sequences described in 9.2. Data transmission.
- The SAMPLE SHIFT mode allow to read directly the 16-bit conversion result of **RegACOutLsb[0x50**] and **RegACOutMsb[0x51**] without a register read sequence. This mode is described in **9.3.1. SAMPLE SHIFT Mode**.
- The COMBINED DATA READY mode is a SAMPLE SHIFT mode which combines the ADC Ready function with the SPI MISO signal to reduce the number of wires to 4 between the master and the slave. This mode is described in 9.3.2. COMBINED DATA READY Mode section.

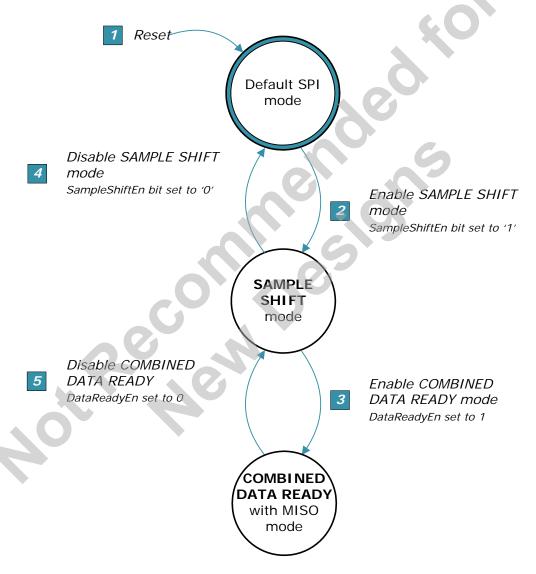


Figure 23. ADC samples reading modes with the SPI interface

When the device is in Sample Shift Mode or Combined Data Ready mode, the register reading will give erroneous data. Always disable the Sample Shift Mode and Combined Data Ready mode to read the registers.

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#### 9.3.1 SAMPLE SHIFT Mode

If the SampleShiftEn bit of **RegACCfg0[0x52]** is active, the MISO/READY pin is used to shift out ADC samples data. The other registers can not be read in this mode. The ADC samples are clocked out at falling edge of SCLK, MSB first (see **Figure 24** below).

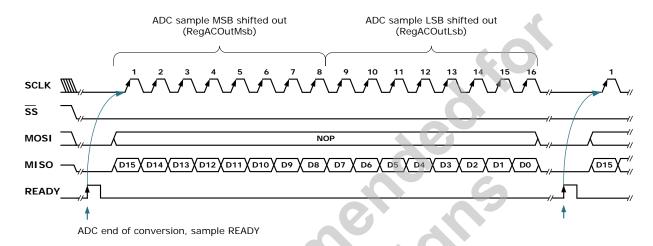


Figure 24. Data Retrieval with the SAMPLE SHIFT Mode (COMBINED DATA READY Mode Disabled)

As illustrated in **Figure 25**, five wires are necessary to connect the master in this mode if to be synchronized to the ADC end of conversion.

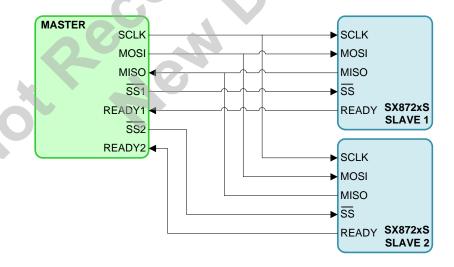


Figure 25. Example with two SX872xS slaves

When the *DataReady* bit is set to '0', this pin functions as *MISO* only. The COMBINED DATA READY mode is disabled.

#### 9.3.2 COMBINED DATA READY Mode

This combined functionality allows for the same control as the SAMPLE SHIFT mode but with fewer pins. Samples shifted out (MISO) are combined with ADC data ready signal (READY). The *DataReadyEn* bit in register

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**RegACCfg4[0x56]** determines the function of this pin. As illustrated in **Figure 26**, four wires are necessary to connect the master in this mode if to be synchronized to the ADC end of conversion. The *DataReadyEn* bit modifies only the  $MISO/\overline{READY}$  pin functionality. The *READY* pin functionality remains unaffected. In either mode, the  $MISO/\overline{READY}$  pin goes to a high-impedance state when  $\overline{SS}$  is taken high.

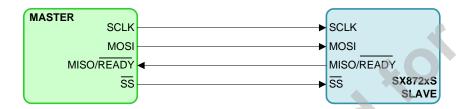


Figure 26. Example of 4-wire Slave

When the *DataReadyEn* bit in **RegACCfg4[0x56]** register is set to '1', this pin functions as both *MISO* and *READY*. Data are shifted out from this pin, MSB first, at the falling edge of *SCLK*. When the *DataReadyModeEn* bit is enabled and a new conversion is complete, *MISO/READY* goes low if it is high. If it is already low, then *MISO/READY* goes high and then goes low (see **Figure 27** below).

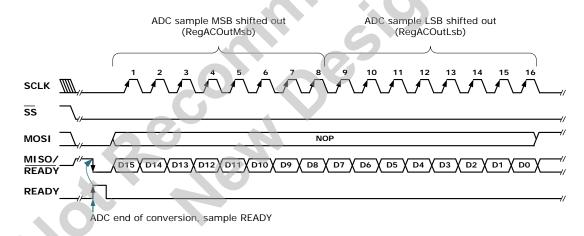


Figure 27. Data Retrieval with the COMBINED DATA READY mode enabled

Similar to the *READY* pin (but with opposite polarity), a falling edge on the *MISO/READY* pin signals that a new conversion result is ready. After *MISO/READY* goes low, the data can be clocked out by providing 16 clocks pulses on *SCLK*.

In order to force  $MISO/\overline{READY}$  high (so that  $MISO/\overline{READY}$  can be polled for a '0' instead of waiting for a falling edge), a no operation command (NOP) or any other command that does not load the data output register can be sent after

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reading out the data. The  $MISO/\overline{READY}$  pin goes high after the first rising edge of SCLK after reading the conversion result completely (see **Figure 28** below).

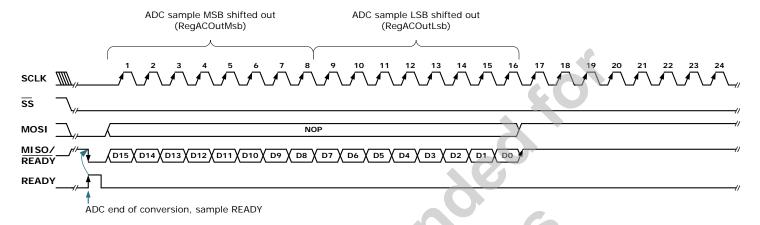


Figure 28. MISO/READY Forced High After Retrieving the Conversion Result

The same condition also applies after a Read Register command. After all the register bits have been read out, the rising edge of *SCLK* forces *MISO/READY* high.

The Combined Data Ready mode must not be used with more than one slave.

To get the interruption on MISO pin,  $\overline{SS}$  should be set to low during all the duration of the Combined Data Ready mode. In Combined Data Ready mode, MISO is set to high after the data reception.

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### 9.4 Chip Start Detection with Slave Select Pin

At power-up or after a soft reset,  $\overline{SS}$  pin is set to output low during the chip initialization (~250us). If the host  $\overline{SS}$  pin is configured at an input pulled high during the power-up sequence, it can detect the SX8723S effective start.

Note that if the host pin has a default output high logical level during the power-up or reset sequences this output it will create a short circuit. Therefore, a resistor should be put on the line to ensure that no current spikes are generated.

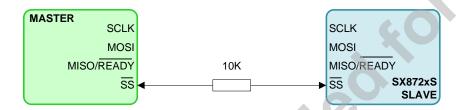


Figure 29. Set a resistor if the host is a high logical level during the startup or the reset

The best value for  $\overline{SS}$  resistor should be between 1 k $\Omega$  and 10 k $\Omega$ . In that range, the current spike is completely avoided and the falling/rising time is ensured.

On **Figure 30** the SPI master uses a separate input for startup status reading. The master  $\overline{SS}$  pin is always configured as output for SPI Slave Select. As in the precedent figure, the resistor on the line to ensure that no current spikes are generated when Master and Slave  $\overline{SS}$  pins are both configured as outputs during a startup sequence.

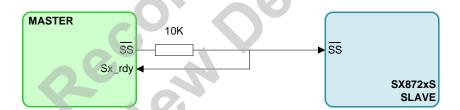


Figure 30. SPI Master using a separate input for startup status reading

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#### 9.5 Improving Noise Immunity

Noise may cause incorrect device operation and incorrect data reception. Careful circuit design and PCB layout prevents much of the problems. Noise immunity can be improved using the following methods:

- Keep SPI lines on the PCB away from noisy lines and devices such as switchers.
- Terminate SPI lines at the device using termination resistors as shown in **Figure 31**.

The recommended value for theses resistors is around 100  $\Omega$ .

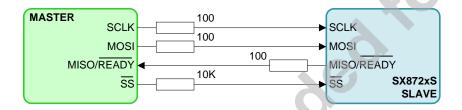


Figure 31. Resistors to improve noise immunity between master and slave

The SCLK, MISO, MOSI and  $\overline{SS}$  lines can also be decoupled with capacitors to increase noise performance. The values of R and C then depend on the transmission speed of the SPI bus. For a transmission speed of around 100 kHz, an R of 100  $\Omega$  and C of 1nF is suggested. For higher transmission speeds, the values of R and C should be reduced accordingly. But if the operating environment is very noisy, larger values of R and C must be selected, and the transmission speed should be reduced.

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# 10 Register Memory Map and Description

#### 10.1 Register Map

**Table 21** below describes the register/memory map that can be accessed through the SPI interface. It indicates the register name, register address and the register contents.

#### Table 21. Register Map

Address	Register	Bit	Description
RC Regist	er		60
0x30	RegRCen	1	RC oscillator control
GPIO Reg	isters		
0x40	RegOut	8	D0 pads data output and direction control
0x41	RegIn	4	D0 pads input data
0x44	RegSoftReset		SPI software reset
ADC Registers			0 6
0x50	RegACOutLsb	8	LSB of ADC result
0x51	RegACOutMsb	8	MSB of ADC result
0x52	RegACCfg0	8	ADC conversion control
0x53	RegACCfg1	8	ADC conversion control
0x54	RegACCfg2	8	ADC conversion control
0x55	RegACCfg3	8	ADC conversion control
0x56	RegACCfg4	8	ADC conversion control
0x57	RegACCfg5	8	ADC conversion control
Mode Reg	jister		
0x70	RegMode	8	Chip operating mode register

## **10.2 Registers Descriptions**

The register descriptions are presented here in ascending order of Register Address. Some registers carry several individual data fields of various sizes; from single-bit values (e.g. flags), upwards. Some data fields are spread across multiple registers. After power on reset the registers will have the values indicated in the tables "Reset" column. Please write the "Reserved" bits with their reset values.

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#### 10.2.1 RC Register

#### Table 22. RegRCen[0x30]

Bit	Bit Name	Mode	Reset	Description
7:1	-	r	0000000	Reserved
0	RCEn	rw	1	Enables RC oscillator. Set 0 for low power mode.

#### Table 23. RegIn[0x41]

Bit	Bit Name	Mode	Reset	Description
7:2	-	r	0000	Reserved
1	D1In	r	-	D1 pad value
0	D0In	r	-	D0 pad value

#### 10.2.2 Software reset register

#### Table 24. RegSoftReset[0x44]

Bit	Name	Mode	Reset	Description
7:0	SoftReset	rw	00000000	Write the 0xDE (b11011110) value into this register to reset the device.

### 10.2.3 ZADC Registers

#### Table 25. RegACOutLsb[0x50]

Bit	Name	Mode	Reset	Description
7:0	Out[7:0]	r	00000000	LSB of the ADC result

#### Table 26. RegACOutMsb[0x51]

	Bit	Name	Mode	Reset	Description
Ī	7:0	Out[15:8]	r	00000000	MSB of the ADC result

#### Table 27. RegACCfg0[0x52]

Bit	Name	Mode	Reset	Description
7	Start	rw	0	Starts an ADC conversion
6:5	SetNelconv	rw	01	Sets the number of elementary conversion to 2 <sup>SetNelconv</sup> .  To compensate for offset the signal is chopped between elementary conversion.

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### Table 27. RegACCfg0[0x52]

Bit	Name	Mode	Reset	Description
4:2	SetOsr	rw	010	Sets the ADC over-sampling rate of an elementary conversion to $2^{3+SetOsr}$ .
1	Continuous	rw	0	Sets the continuous ADC conversion mode
0	SampleShiftEn	rw	0	ADC samples can be read directly on the SPI See section 9.3.1, page 39.

#### Table 28. RegACCfg1[0x53]

Bit	Name	Mode	Reset	Description
7:6	IbAmpAdc	rw	11	Bias current selection for the ADC
5:4	IbAmpPga	rw	11	Bias current selection for the PGA
3		rw	0	PGA3 enable
2	— Enable	rw	0	PGA2 enable
1	Enable	rw	0	PGA1 enable
0		rw	0	ADC enable

#### Table 29. RegACCfg2[0x54]

Bit	Name	Mode	Reset	Description
7:6	SetFs	rw	00	ADC Sampling Frequency selection
5:4	Pga2Gain	rw	00	PGA2 gain selection
3:0	Pga2Offset	rw	0000	PGA2 offset selection

#### Table 30. RegACCfg3[0x55]

Bit	Name	Mode	Reset	Description
7	Pga1Gain	rw	0	PGA1 gain selection
6:0	Pga3Gain	rw	0001100	PGA3 gain selection

#### Table 31. RegACCfg4[0x56]

Bit	Name	Mode	Reset	Description
7	DataReadyEn	rw	0	Combined SPI MISO and ADC Data Ready signal. 0: Combined Data Ready mode disabled 1: Combined Data Ready mode enabled See section 9.3.2, page 39.
6:0	Pga3Offset	rw	0000000	PGA3 offset selection

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#### Table 32. RegACCfg5[0x57]

Bit	Name	Mode	Reset	Description			
7	Busy	r	0	ADC activity flag			
6	Def	rw	0	Selects ADC and PGA default configuration, starts an ADC conversion			
5:1	Amux	rw	00000	Input channel configuration selector			
0	Vmux	rw	0	Reference channel selector 0: VBATT 1: VREF			

#### 10.2.4 Mode Registers

#### Table 33. RegMode[0x70]

Bit	Name	Mode	Reset	Description
7	-	r	1	reserved
6	-	r	0	reserved
5:4	Chopper	rw	00	VREF chopping control. Note 1 11: Chop at NELCONV/2 rate 10: Chop at NELCONV rate 01: Chop state=1 00: Chop state=0
3	MultForceOn	rw	0	Force charge pump On. Takes priority. Note 2
2	MultForceOff	rw	1	Force charge pump Off. Note 2
1	VrefD0Out	rw	0	Enable VREF output on D0 pin
0	VrefD1In	rw	0	Enable external VREF on D1 pin

- (1) The chop control is to allow chopping of the internal bandgap reference. This may be useful to help eliminate bandgap related internal offset voltage and 1/f noise. The bandgap chop state may be forced High or Low, or may be set to toggle during conversion at either the same rate or half the rate of the Elementary Conversion. (See Conversion Sequence in the ZoomingADC description).
- (2) The internal charge pump may be forced On when VBATT supply is below 3V or Off when VBATT supply is above 3V. Enabling the charge pump increase the current consumption. If the ADC is not being run at full rate or full accuracy then it may operate sufficiently well when VBATT is less than 3V and internal charge pump forced Off.



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# 11 Typical Performances

#### Note

The graphs and tables provided following this note are statistical summary based on limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range and therefore outside the warranted range.

#### 11.1 Input impedance

The *PGAs* of the ZoomingADC are a switched capacitor based blocks (see Switched Capacitor Principle section). This means that it does not use resistors to fix gains, but capacitors and switches. This has important implications on the nature of the input impedance of the block.

Using switched capacitors is the reason why, while a conversion is done, the input impedance on the selected channel of the *PGAs* is inversely proportional to the sampling frequency *fs* and to stage gain as given in **Equation 24**.

$$Z_{in} \ge \frac{1}{\left(Cg \cdot gain + Cp\right)} \left[\Omega\right]$$

#### Equation 24

The input impedance observed is the input impedance of the first PGA stage that is enabled or the input impedance of the ADC if all three stages are disabled.

Cg multiplied by gain is the equivalent gain capacitor and Cp is the parasitic capacitor of the first enabled stage. The values for each ZoomingADC bloc are provided in **Table 34**:

**Table 34.** Capacitor values

Acquisition Chain Stage	Gain capacitor Cg	Parasitic capacitor Cp	Units			
PGA1	0.45	1.04	рF			
PGA2	0.54	1.5	pF			
PGA3	0.775	1.8	рF			
ADC	2.	2.67				

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**Table 34** gives typical impedance values for various gain configurations.

**Table 35. Typical Input Impedances** 

$\mathbf{Z}$ IN $[\mathbf{M}\Omega]$		PGA1	gain	PGA2 gain			PGA3 gain					
		1	10	1	2	5	10	1	2	4	8	10
fs [kHz]	62.5	10.26	2.59	7.95	5.05	2.84	2.24	6.25	4.32	2.86	1.87	1.63
	125	5.14	1.30	3.99	2.54	1.44	1.11	3.13	2.16	1.43	0.94	0.82
	250	2.57	0.65	1.98	1.26	0.71	0.56	1.56	1.08	0.72	0.47	0.41
	500	1.29	0.32	0.99	0.63	0.36	0.28	0.78	0.54	0.36	0.24	0.21

*PGA1* (with a gain of 10) and *PGA2* (with a gain of 10) have each a minimum input impedance of 300 k $\Omega$  at fs = 500 kHz. *PGA3* (with a gain of 10) have a minimum input impedance of 250 k $\Omega$  at fs = 500 kHz.

Larger input impedance can be obtained by reducing the gain and/or by reducing the over-sampling frequency fs. Therefore, with a gain of 1 and a sampling frequency of 62.5 kHz, Zin > 10.2 M $\Omega$  for *PGA1*.

The input impedance on channels that are not selected is very high (>10M $\Omega$ ).

#### 11.1.1 Switched Capacitor Principle

Basically, a switched capacitor is a way to emulate a resistor by using a capacitor. The capacitors are much easier to realize on CMOS technologies and they show a very good matching precision.



Figure 32. The Switched Capacitor Principle

A resistor is characterized by the current that flows through it (positive current leaves node  $V_1$ ):

$$I = \frac{V_1 - V_2}{R} \quad [A]$$

#### **Equation 25**

One can verify that the mean current leaving node  $V_1$  with a capacitor switched at frequency f is:

$$\langle I \rangle = (V1 - V2) \cdot C \quad [A]$$

**Equation 26** 

#### ZoomingADC for sensing data acquisition

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Therefore as a mean value, the switched capacitor  $1/(f \times C)$  is equivalent to a resistor. It is important to consider that this is only a mean value. If the current is not integrated (low impedance source), the impedance is infinite during the whole time but the transition.

What does it mean for the ZoomingADC?

If the fs clock is reduced, the mean impedance is increased. By dividing the fs clock by a factor 10, the impedance is increased by a factor 10.

One can reduce the capacitor that is switched by using an amplifier set to its minimal gain. In particular if *PGA1* is used with gain 1, its mean impedance is 10x bigger than when it is used with gain 10.

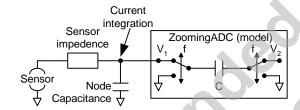


Figure 33. The Switched Capacitor Principle

One can increase the effective impedance by increasing the electrical bandwidth of the sensor node so that the switching current is absorbed through the sensor before the switching period is over. Measuring the sensor node will show short voltage spikes at the frequency fs, but these will not influence the measurement. Whereas if the bandwidth of the node is lower, no spikes will arise, but a small offset can be generated by the integration of the charges generated by the switched capacitors, this corresponds to the mean impedance effect.

#### Notes:

- (1) One can increase the mean input impedance of the ZoomingADC by lowering the acquisition clock fs.
- (2) One can increase the mean input impedance of the ZoomingADC by decreasing the gain of the first enabled amplifier.
- (3) One can increase the effective input impedance of the ZoomingADC by having a source with a high electrical bandwidth (sensor electrical bandwidth much higher than fs).

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#### 11.2 Frequency Response

The incremental *ADC* is an over-sampled converter with two main blocks: an analog modulator and a low-pass digital filter. The main function of the digital filter is to remove the quantization noise introduced by the modulator. This filter determines the frequency response of the transfer function between the output of the *ADC* and the analog input *VIN*. Notice that the frequency axes are normalized to one elementary conversion period *OSR / fs*. The plots of **Figure 34**, **page 52** also show that the frequency response changes with the number of elementary conversions *NELCONV* performed. In particular, notches appear for *NELCONV* >= 2 These notches occur at:

$$f_{NOTCH} = \frac{i \cdot f_s}{OSR \cdot N_{ELCONV}}$$
 For  $i = 1, 2, ...(N_{ELCONV} - 1)$ 

**Equation 27** 

and are repeated every fs / OSR.

Information on the location of these notches is particularly useful when specific frequencies must be filtered out by the acquisition system. This chip has no dedicated 50/60 Hz rejection filtering but some rejection can be achieved by using **Equation 27** and setting the appropriate values of *OSR*, *fs* and *NELCONV*.

**Table 36. 50/60 Hz Line Rejection Examples** 

Rejection [Hz]	fnотсн [Hz]	fs [kHz]	OSR [-]	NELCONV [-]
	61	125	1024	2
60	61	250	1024	4
	61	500	1024	8
	53	62.5	1024	8
50	46	62.5	1024	4
	46	125	1024	8

## ZoomingADC for sensing data acquisition

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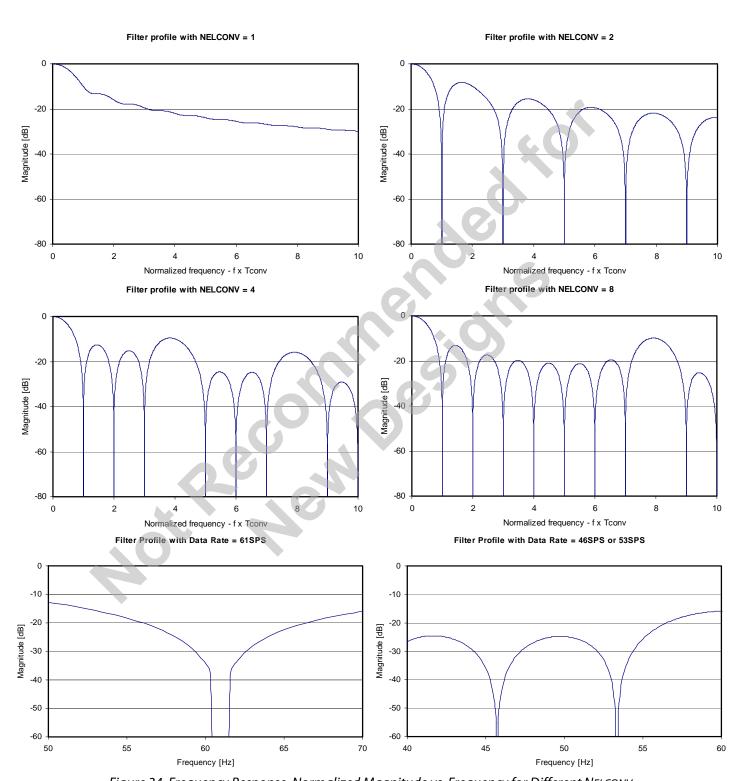


Figure 34. Frequency Response. Normalized Magnitude vs. Frequency for Different NELCONV

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#### 11.3 Linearity

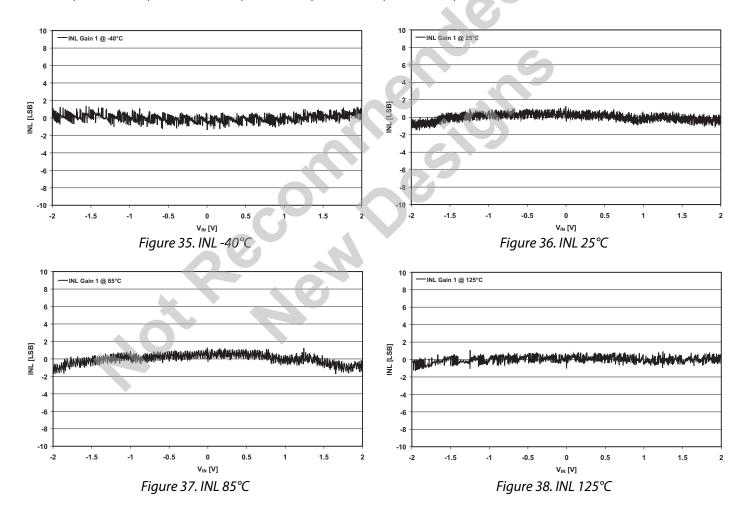
#### 11.3.1 Integral Non-Linearity

The different *PGA* stages have been designed to find the best compromise between the noise performance, the integral non-linearity and the power consumption. To obtain this, the first stage has the best noise performance and the third stage the best linearity performance. For large input signals (small *PGA* gains, i.e. up to about 50), the noise added by the *PGA* is very small with respect to the input signal and the second and third stage of the *PGA* should be used to get the best linearity. For small input signals (large gains, i.e. above 50), the noise level in the *PGA* is important and the first stage of the *PGA* should be used.

The following figures show the Integral non linearity for different gain settings over the chip temperature range

#### 11.3.1.1 Gain 1

VBATT=5V; VREF=VBATT; PGAs disabled; OSR=1024; Nelconv=8; fs=250kHz; Resolution=16bits.



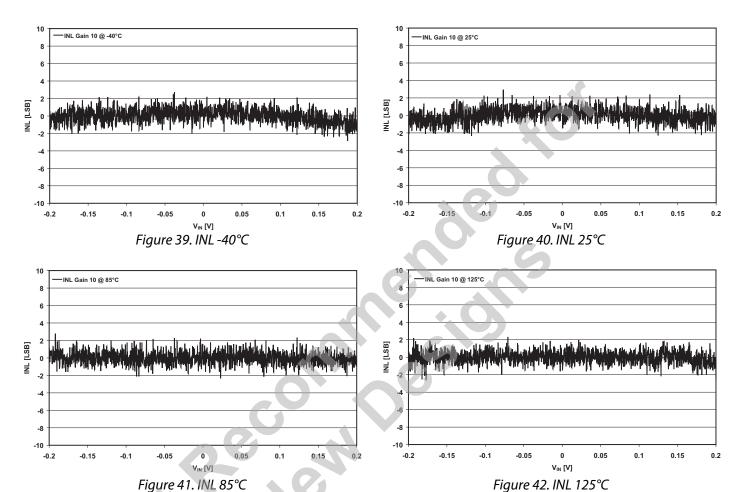
## ZoomingADC for sensing data acquisition

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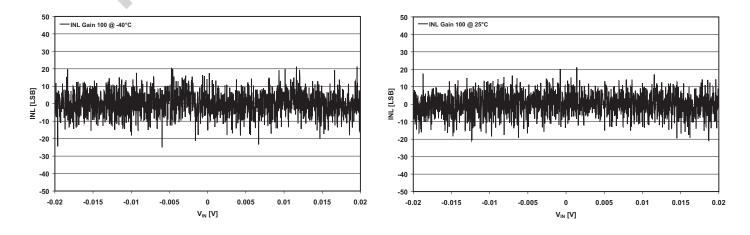
#### 11.3.1.2 Gain 10

VBATT=5V; VREF=VBATT; ADC and PGA3 enabled; GD3=10; OSR=1024; Nelconv=8; fs=250kHz; Resolution=16bits.



#### 11.3.1.3 Gain 100

VBATT=5V; VREF=VBATT; ADC, PGA2 and PGA3 enabled; GD2=10; GD3=10; OSR=1024; Nelconv=8; fs=250kHz; Resolution=16bits.



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Figure 43. INL -40°C

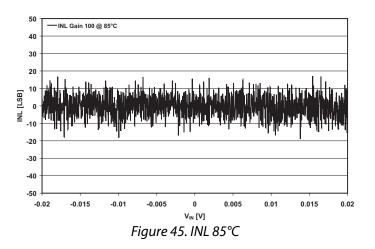


Figure 44. INL 25°C

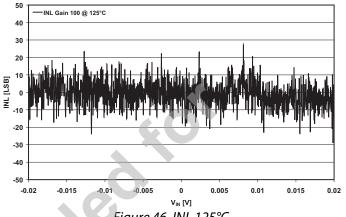
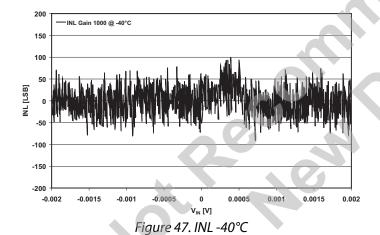


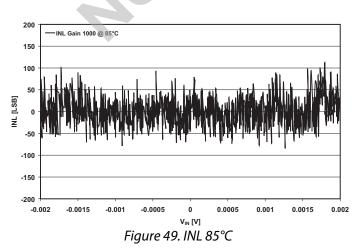
Figure 46. INL 125°C

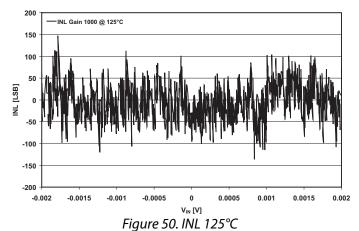
#### 11.3.1.4 Gain 1000

VBATT=5V; VREF=VBATT; ADC, PGA3, PGA2, PGA1 enabled; GD1=10, GD2=10, GD3=10; OSR=1024; NELCONV=8; fs=250KHz; Resolution=16bits.



INL Gain 1000 @ 25°C 150 -150 -0.0015 -0.001 0.0005 0.001 0.0015 0.002 -0.002 VIN [V] Figure 48. INL 25℃







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#### 11.3.2 Differential Non-Linearity

The differential non-linearity is generated by the ADC. The PGA does not add differential non-linearity. Figure 51 shows the differential non-linearity.

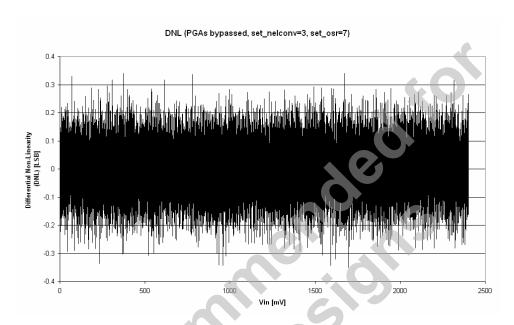


Figure 51. Differential Non-Linearity of the ADC Converter

#### 11.4 Noise

Ideally, a constant input voltage Vin should result in a constant output code. However, because of circuit noise, the output code may vary for a fixed input voltage. Thus, a statistical analysis on the output code of 1200 conversions for a constant input voltage was performed to derive the equivalent noise levels of PGA1, PGA2, and PGA3.

The extracted RMS output noise of PGA1, 2, and 3 are given in Table 37, page 58: standard output deviation and output rms noise voltage.

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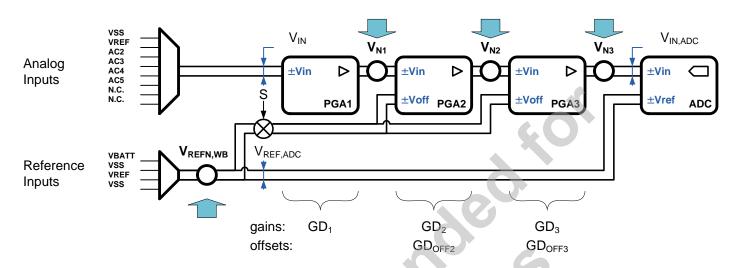


Figure 52. Simple Noise Model for PGAs and ADC

VN1, VN2, and VN3 are the output RMS noise figures of **Table 37**, GD1, GD2, and GD3 are the PGA gains of stages 1 to 3 respectively. VREFN,WB is the wide band noise on the reference voltage.

The simple noise model of **Figure 52** is used to estimate the equivalent input referred RMS noise *V*<sub>N,IN</sub> of the acquisition chain in the model of **Figure 54**, **page 58**. This is given by the relationship:

$${V_{N,IN}}^{2} = \frac{{{{\left( {\frac{{{V_{N1}}}}{G{D_{1}}}} \right)}^{2}} + {{\left( {\frac{{{V_{N2}}}}{G{D_{1}} \cdot G{D_{2}}}} \right)}^{2}} + {{\left( {\frac{{{V_{N3}}}}{G{D_{TOT}}}} \right)}^{2}} + {{\left( {\frac{{{V_{REFN,WB}}{\left( {G{D_{2}} \cdot G{D_{OFF2}} + G{D_{OFF3}}} \right)}}{G{D_{TOT}}}} \right)}^{2}} + {{\left( {\frac{1}{2} \cdot \frac{{{V_{REFN,WB}}}}{G{D_{TOT}}}} \right)}^{2}}}{{\left( {OSR \cdot {N_{FICONV}}} \right)}}} \left[ {V^{2}rms} \right]$$

#### **Equation 28**

On the numerator of **Equation 28**:

- 1 the first parenthesis is the PGA1 gain amplifier contribution to noise
- 2 the second parenthesis is the PGA2 gain amplifier contribution to noise
- 3 the third parenthesis is the PGA3 gain amplifier contribution to noise
- 4 the fourth parenthesis is PGA2 and PGA3 offset amplifiers contributions to noise
- 5 the last parenthesis is the contribution of the noise on the references of the ADC

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As shown in **Equation 28**, noise can be reduced by increasing *OSR* and *NELCONV* (increases the *ADC* averaging effect, but reduces noise).

Table 37. PGA Noise Measurement (n = 16bits, OSR = 512, NELCONV = 2, VREF = 5V)

Parameter	PGA1	PGA2	PGA3
Output RMS noise [uV]	Vn1 = 205	V <sub>N2</sub> = 340	V <sub>N3</sub> = 365

**Figure 53** shows the distribution for the *ADC* alone (*PGA1*, 2, and 3 bypassed). Quantization noise is dominant in this case, and, thus, the *ADC* thermal noise is below 16 bits.

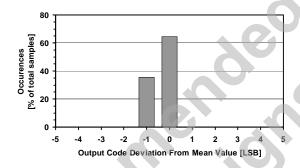


Figure 53. ADC Noise (PGA1, 2 & 3 Bypassed, OSR = 512, NELCONV = 2)

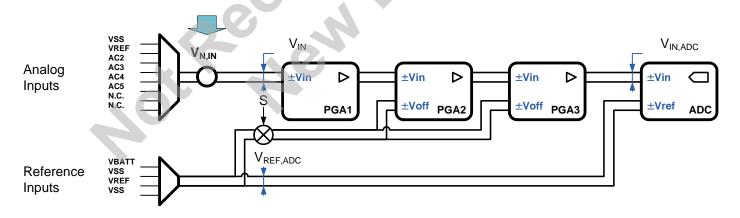


Figure 54. Total Input Referred Noise

As an example, consider the system where: GD2 = 10 (GD1 = 1; PGA3 bypassed), OSR = 512, NELCONV = 2, VREF = 5 V. In this case, the noise contribution VN1 of PGA1 is dominant over that of PGA2. Using **Equation 28**, **page 57**, we get:  $VN,IN = 6.4 \, \mu\text{V}$  (RMS) at the input of the acquisition chain, or, equivalently, 0.85 LSB at the output of the ADC. Considering 0.2 V (RMS) maximum signal amplitude, the signal-to-noise ratio is 90dB.

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#### 11.5 Gain Error and Offset Error

Gain error is defined as the amount of deviation between the ideal transfer function (theoretical **Equation 19**, **page 30**) and the measured transfer function (with the offset error removed).

The actual gain of the different stages can vary depending on the fabrication tolerances of the different elements. Although these tolerances are specified to a maximum of  $\pm 3\%$ , they will be most of the time around  $\pm 0.5\%$ . Moreover, the tolerances between the different stages are not correlated and the probability to get the maximal error in the same direction in all stages is very low. Finally, these gain errors can be calibrated by the software at the same time with the gain errors of the sensor for instance.

**Figure 55** shows gain error drift vs. temperature for different *PGA* gains. The curves are expressed in% of Full-Scale Range (*FSR*) normalized to 25°C.

Offset error is defined as the output code error for a zero volt input (ideally, output code = 0). The offset of the ADC and the PGA1 stage are completely suppressed if NELCONV > 1.

The measured offset drift vs. temperature curves for different PGA gains are depicted in **Figure 56**. The output offset error, expressed in LSB for 16-bit setting, is normalized to 25°C. Notice that if the *ADC* is used alone, the output offset error is below +/-1 LSB and has no drift.

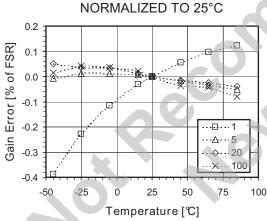


Figure 55. Gain Error vs. Temperature for Different Gains

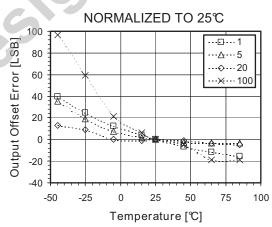


Figure 56. Offset Error vs. Temperature for Different Gains

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#### **11.6 Power Consumption**

As mentioned in **section 6.4, page 16** the Charge Pump must be enabled if VBATT is below 3V. **Figure 57** plots the variation of current consumption with supply voltage *VBATT*, as well as the distribution between the 3 *PGA* stages and the *ADC* (see **Table 38, page 61**). In this case the Charge Pump is forced ON for VBATT < 4.2V and forced OFF for VBATT > 4.2V.

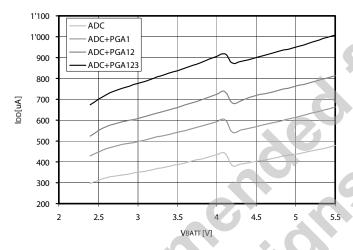


Figure 57. Current Consumption vs. Supply Voltage and PGAs

As shown in **Figure 58**, if lower sampling frequency is used, the current consumption can be lowered by reducing the bias currents of the *PGAs* and the *ADC* with registers *lbAmpPga* and *lbAmpAdc*. (In **Figure 58**, *lbAmpPga/Adc* = '11', '10', '00' for fs = 500, 250, 62.5 kHz respectively. In this case the Charge Pump is forced ON for VBATT < 4.2V and forced OFF for VBATT > 4.2V.

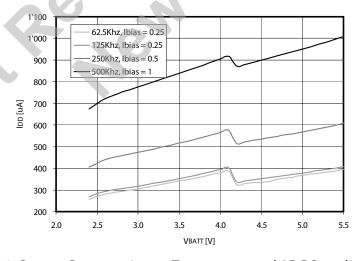


Figure 58. Current Consumption vs. Temperature and ADC Sampling Frequency

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Current consumption vs. temperature is depicted in Figure 59, showing the increase between -40 and +125°C.

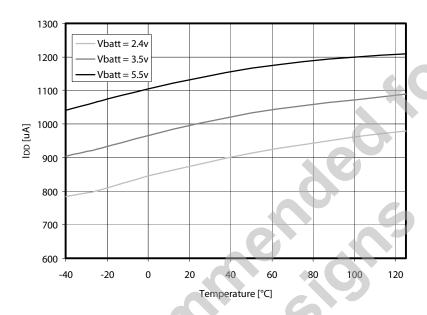


Figure 59. Current Consumption vs. Temperature and Supply Voltage

Table 38. Typical Current Distribution in Acquisition Chain (n = 16 bits, fs = 250kHz)

Supply	ADC	PGA1	PGA2	PGA3	Total	Unit
VBATT = 2.4V	207	70	51	78	406	
VBATT = 3.5V	282	82	61	91	516	uA
VBATT = 5.5V	338	103	67	98	606	

## ZoomingADC for sensing data acquisition

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#### **FAMILY OVERVIEW**

This chapter gives an overview of similar devices based on the ZoomingADC but with different features or packages. Each part is described in it's own datasheet.

# 12 Comparison Table

Table 39. Family Comparison Table

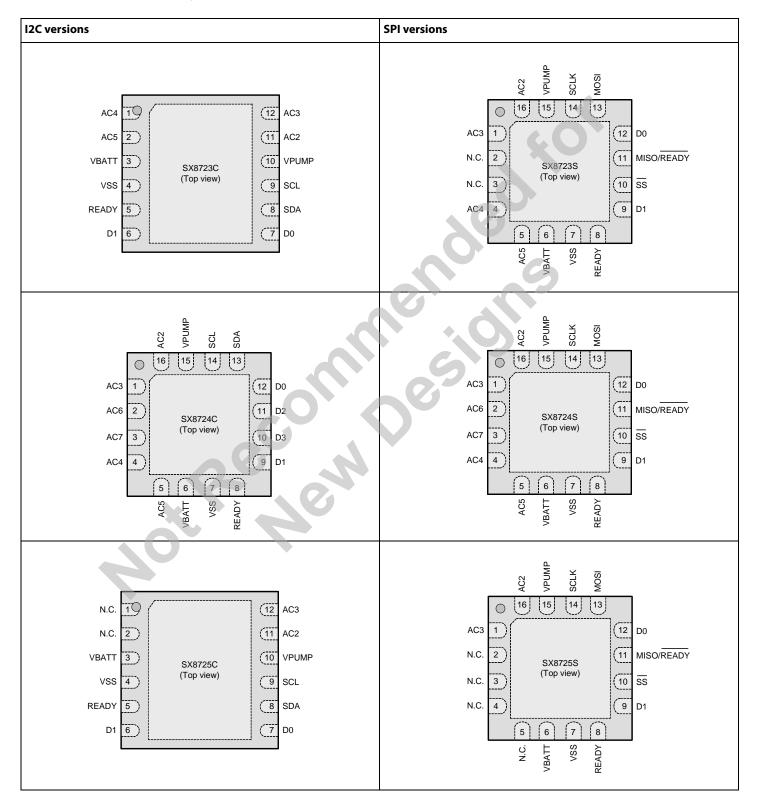
		Part number						
		SX8723C	SX8724C	SX8725C	SX8723S	SX8724S	SX8725S	
Package		MLPD-W-12 4x4	MLPQ-16 4x4	MLPD-W-12 4x4	MLPQ-16 4x4	MLPQ-16 4x4	MLPQ-16 4x4	
Protocol		I2C	I2C	I2C	SPI	SPI	SPI	
D	0	I2C addr, Digital I2C addr, Digital IO or Vref OUT IO or Vref OUT		I2C add, Digital IO or Vref OUT	Digital IO or Vref OUT	Digital IO or Vref OUT	Digital IO or Vref OUT	
GPIO D	D1 I2C addr, Digital I		I2C addr, Digital IO or Vref IN	I2C addr, Digital IO or Vref IN	Digital IO or Vref OUT.	Digital IO or Vref IN	Digital IO or Vref IN	
D	<b>N</b> .A.		Digital IO	N.A.	N.A.	N.A.	N.A.	
D	3	N.A. Digital IO		N.A.	N.A.	N.A.	N.A.	
Differential input channels		2	3	1	2	3	1	
			SCO					



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# 13 Comparison by package pinout



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#### MECHANICAL

## 14 PCB Layout Considerations

PCB layout considerations to be taken when using the SX8723S are relatively simple to get the highest performances out of the ZoomingADC. The most important to achieve good performances out the ZoomingADC is to have a good voltage reference. The SX8723S has already an internal reference that is good enough to get the best performances with a minimal amount of external components, but, in case an external reference is needed this one must be as clean as possible in order to get the desired performance. Separating the digital from the analog lines will be also a good choice to reduce the noise induced by the digital lines. It is also advised to have separated ground planes for digital and analog signals with the shortest return path, as well as making the power supply lines as wider as possible and to have good decoupling capacitors.

#### 15 How to Evaluate

For evaluation purposes SX8724SEVK evaluation kit can be ordered. This kit connects to any PC using a USB port. A software gives the user the ability to control the registers as well as getting the raw data from the ZoomingADC and displaying it on the "Graphical User Interface". For more information please look at SEMTECH web site (http://www.semtech.com/analog-controllers-sensors-converters/).

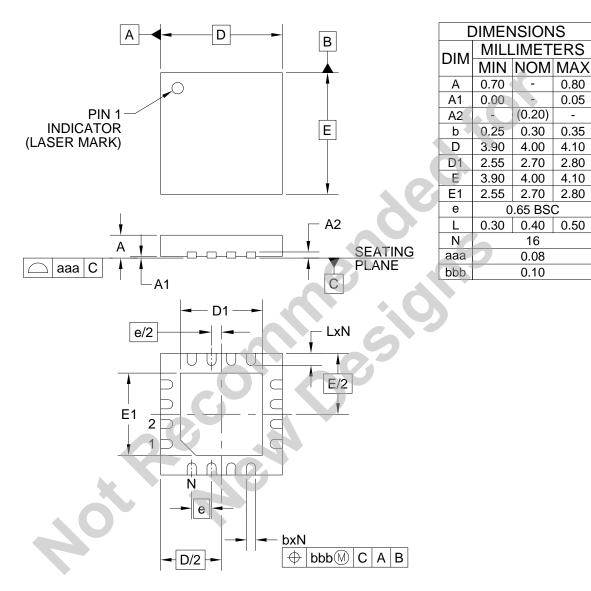
COLUMN



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# 16 Package Outline Drawing: MLPQ-W16-4x4-EP1



#### NOTES:

- 1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
- 2. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

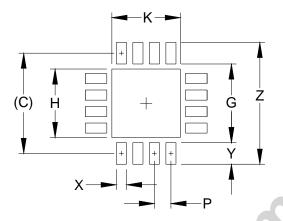
Figure 60. Package Outline Drawing



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# 17 Land Pattern Drawing: MLPQ-W16-4x4-EP1



	DIMENSIONS							
DIM	INCHES	MILLIMETERS						
С	(.156)	(3.95)						
G	.122	3.10						
Н	.106	2.70						
K	.106	2.70						
Р	.026	0.65						
X	.016	0.40						
Y	.033	0.85						
Z	.189	4.80						

#### NOTES:

- 1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
- 2. THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY. CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR COMPANY'S MANUFACTURING GUIDELINES ARE MET.
- 3. THERMAL VIAS IN THE LAND PATTERN OF THE EXPOSED PAD SHALL BE CONNECTED TO A SYSTEM GROUND PLANE. FAILURE TO DO SO MAY COMPROMISE THE THERMAL AND/OR FUNCTIONAL PERFORMANCE OF THE DEVICE.
- 4. SQUARE PACKAGE DIMENSIONS APPLY IN BOTH " X " AND " Y " DIRECTIONS.

Figure 61. Land Pattern Drawing

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# 18 Tape and Reel Specification

MLP/QFN (0.70mm - 1.00mm package thickness)

- Single Sprocket holes
- Tolerances for Ao & Bo are +/- 0.20mm
- Tolerances for Ko is +/- 0.10mm
- Tolerance for Pocket Pitch is +/- 0.10mm
- Tolerance for Tape width is +/-0.30mm
- Trailer and Leader Length are minimum required length
- Package Orientation and Feed Direction

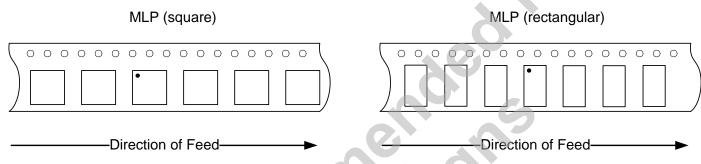


Figure 62. Direction of Feed

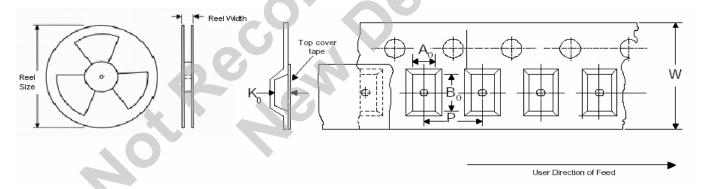


Figure 63. User direction of feed

#### Table 40. Tape and reel specifications

Pkg size	carrier tape (mm)				Reel					
	Tape	Pocket	Ao	Во	Ko	Reel Size	Reel	Trailer	Leader	QTY per
	Width	Pitch (P)				(in)	Width	Length (mm)	Length	Reel
	(W)						(mm)		(mm)	
4x4	12	8	4.35	4.35	1.10	7/13	12.4	400	400	1000/3000

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